

CE EMC Test Report

Equipment : Bluetooth Serial Module with integrated antenna
(Please refer to section 1.1.1 for more details.)

Model No. : BTM431
(Please refer to section 1.1.1 for more details.)

Brand Name : Laird Technologies

Applicant : Laird Technologies

Address : 11160 Thompson Ave. / Lenexa, Kansas / 66219 / USA

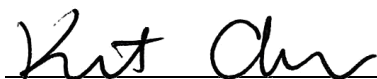
Standard : EN 301 489-1 V1.9.2 (2011-09)
EN 301 489-17 V2.2.1 (2012-09)

Received Date : Aug. 06, 2014

Tested Date : Aug. 19 ~ Aug. 25, 2014

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Approved & Reviewed by:



Kent Chen / Assistant Manager



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Release Record

Report No.	Version	Description	Issued Date
EH480602	Rev. 01	Initial issue	Sep. 01, 2014

Summary of Test Results

EN 301 489-1 Emission Tests				
Ref. Std. Clause	Test Standard	Test Items	Measured	Result
8.3/8.4	EN 55022:2010/AC:2011, Class B	Conducted Emissions	-11.19dB AV@ 0.202MHz.	Pass
8.7	EN 55022:2010/AC:2011, Class B	Conducted Emissions at Telecommunication Ports	Note ¹	N/A
8.2	EN 55022:2010/AC:2011, Class B	Radiated Emissions	Note ²	N/A
8.5	EN 61000-3-2:2006/A1:2009 and A2:2009, Class A	Harmonic Current Emissions	Note ³	N/A
8.6	EN 61000-3-3:2013	Voltage Fluctuations and Flicker	Note ³	N/A
N/A means Not Applicable. Note¹: The EUT w/o telecom port. Note²: According to Clause 7.1 of EN 301 489-1, the test is not required. Note³: The EUT consumes DC power, so the test is not required.				

EN 301 489-1 Immunity Tests					
Ref. Std. Clause	Test Standard	Description of Test		Pass Criterion	Result
9.3	EN 61000-4-2:2009	Electrostatic Discharge (ESD)		A	Pass
9.2	EN 61000-4-3:2006/A1:2008/A2:2010	Radio Frequency Electromagnetic Field (RS)		A	Pass
9.4	EN 61000-4-4:2012	Electrical Fast Transient/Burst (EFT)		Note ¹	N/A
9.8	EN 61000-4-5:2006	Surge		Note ²	N/A
9.5	EN 61000-4-6:2009	Conducted Disturbances (CS)		Note ¹	N/A
9.7	EN 61000-4-11:2004	Voltage Dips	0% residual for 0.5 cycle	Note ²	N/A
			0% residual for 1 cycle	Note ²	N/A
			70% residual for 25 cycle	Note ²	N/A
		Voltage Interruption	0% residual for 250 cycle (w/o battery back-up)	Note ²	N/A
N/A means Not Applicable. Note ¹ : The EUT consumes DC power, and it is not intended to be used with cables longer than 3m. So this test is not carried out. Note ² : The EUT consumes DC power, so the test is not required.					

1 General Description

1.1 Information

1.1.1 Product Details

The following models are provided to this EUT.

Brand Name	Model Name	Product Name	Description
Laird Technologies	BTM411 / BTM421 / BTM431 / BTM441 / BTM443 / BTM461	Bluetooth Serial Module with integrated antenna	Surface mount module with chip antenna
Laird Technologies	BTM410 / BTM420 / BTM430	Bluetooth Serial Module with surface mount pad for external antenna	Surface mount pad with dipole antenna.
Model Name	Difference		
BTM411	Class 2 Bluetooth AT Data Module using CSR Unified Stack 2.1+EDR		
BTM421	Class 2 Bluetooth HCI data module using CSR HCI Stack 2.1+EDR		
BTM431	Class 2 Bluetooth AT Data Module using CSR Unified Stack 2.0+EDR		
BTM441	Class 2 Bluetooth with Multipoint using CCL Interface Express Subsystem 2.1+EDR		
BTM443	Class 2 Bluetooth AT Data module using CCL Interface Express Subsystem 2.1+EDR		
BTM461	Class 2 Bluetooth AT / Multipoint using CCL Interface Express Subsystem 2.1+EDR		
✦ Hardware is the same on all of these modules. Only difference is the Bluetooth firmware installed.			
Model Name	Difference		
BTM410	Class 2 Bluetooth AT Data Module using CSR Unified Stack 2.1+EDR		
BTM420	Class 2 Bluetooth HCI data module using CSR HCI Stack 2.1+EDR		
BTM430	Class 2 Bluetooth AT Data Module using CSR Unified Stack 2.0+EDR		
✦ Hardware is the same on all of these modules. Only difference is the Bluetooth firmware installed.			

✧ The above models, model **BTM420**, **BTM421**, **BTM430**, **BTM431**, and **BTM461** were selected as representative ones for pretesting.

1.1.2 Specification of the Equipment under Test (EUT)

Operating Frequency	2402 MHz ~ 2480 MHz
Antenna Type	Refer to section 1.1.3
Modulation Type	GFSK, $\pi/4$ -DQPSK and 8DPSK

1.1.3 Antenna Details

Ant. No.	Model	Type	Connector	Gain (dBi)	Remark
1	2450AT42B100	Surface Mount Ceramic Chip	NA	0	Populated on BTM411 / BTM421 / BTM431 / BTM441 / BTM443 / BTM461
2	S181AH-2450S	Dipole	RP-SMA	2	Used with BTM410 / BTM420 / BTM430

1.1.4 Power Supply Type of the Equipment under Test (EUT)

Power Supply Type	3Vdc from host
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1.1.5 Accessories

N/A

1.2 Test Equipment and Calibration Data

Test Item	Conducted Emission				
Test Site	Conduction room 1 / (CO01-WS)				
Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Calibration Until
EMC Receiver	R&S	ESCS 30	100169	Oct. 15, 2013	Oct. 14, 2014
LISN	SCHWARZBECK	Schwarzbeck 8127	8127-667	Nov. 23, 2013	Nov. 22, 2014
LISN (Support Unit)	SCHWARZBECK	Schwarzbeck 8127	8127-666	Dec. 04, 2013	Dec. 03, 2014
RF Cable-CON	Woken	CFD200-NL	CFD200-NL-001	Apr. 23, 2014	Apr. 22, 2015
50 ohm terminal (Support Unit)	NA	50	04	Apr. 18, 2014	Apr. 17, 2015
Note: Calibration Interval of instruments listed above is one year.					

Test Item	ESD				
Test Site	ESD room 1 / (ES01-WS)				
Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Calibration Until
ESD Generator	EMTest	Dito	V1248114239	Aug. 13, 2014	Aug. 12, 2015
Note: Calibration Interval of instruments listed above is one year.					

Test Item	Radiated Immunity (80 MHz - 6 GHz)				
Test Site	RS room 1 / (RS01-WS)				
Instrument	Manufacturer	Model No.	Serial No.	Calibration Date	Calibration Until
Signal Generator	R & S	SMB100A	103294HA	Oct. 29, 2013	Oct. 28, 2014
Power Sensor	R & S	NRP-Z91	101094-UL	Nov. 01, 2013	Oct. 31, 2014
Power Sensor	R & S	NRP-Z91	101095-KY	Nov. 01, 2013	Oct. 31, 2014
Power Amplifier	BONN	BLWA 0810-160/100D	107972A	N/A	N/A
Power Amplifier	BONN	BLMA 1060-100D	107972B	N/A	N/A
Antenna	R & S	HL046E	100076-Cd	N/A	N/A
Note: Calibration Interval of instruments listed above is one year.					

1.3 Testing Applied Standards

According to the specifications of the manufacturer, the EUT must comply with the requirements of the following standards:

EN 301 489-1 V1.9.2 (2011-09)
EN 301 489-17 V2.2.1 (2012-09)

1.4 Measurement Uncertainty

ISO/IEC 17025 requires that an estimate of the measurement uncertainties associated with the emissions test results be included in the report. The measurement uncertainties given below are based on a 95% confidence level (based on a coverage factor ($k=2$))

Measurement Uncertainty		
Test Item	Frequency	Uncertainty
Conducted Emissions	150kHz ~ 30MHz	± 2.92 dB

2 Test Configuration

2.1 Testing Condition

Test Item	Test Site	Ambient Condition	Tested By
AC Conduction	CO01-WS	22°C/53%	Skys Huang
ESD	ES01-WS	25°C/55%/ 97kPa	JN Chen
RS	RS01-WS	25°C/55%/ 97kPa	JN Chen

2.2 The Worst Case Measurement Configuration

The Worst Test Configurations	
Conducted Emissions	
Test Mode	Operating Description
1	Tx Mode, model: BTM420
2	Tx Mode, model: BTM421
3	Normal mode, model: BTM430
4	Normal mode, model: BTM431
5	Tx Mode, model: BTM461
Immunity Tests	
Test Mode	Operating Description
1	Tx Mode, model: BTM420
2	Tx Mode, model: BTM421
3	Normal mode, model: BTM430
4	Normal mode, model: BTM431
5	Tx Mode, model: BTM461

2.3 Local Support Equipment List

Support Equipment List (EMI)					
No.	Equipment	Brand	Model	S/N	Signal cable / Length (m)
1	Notebook	DELL	Latitude E5430	6R4RWW1	---
2	Notebook	DELL	Latitude E5430	264RWW1	---
3	Printer	EPSON	XP-30	QSDK002461	USB, 1.8m shielded w/o core.
4	Mouse	DELL	MS111-L	2C3-00NM	USB, 1.8m shielded w/o core.
5	USB 3.0 HDD	WD	WDBKXH500 0ABK	WX31AB2102 13	USB, 0.5m shielded w/o core.
6	Spectrum Analyzer	ADVENTEST	R3132	130802566	---
7	BT 2.0 Dongle	Laird	BRBLU3-010 A0-03	AN1203955	---

Note:

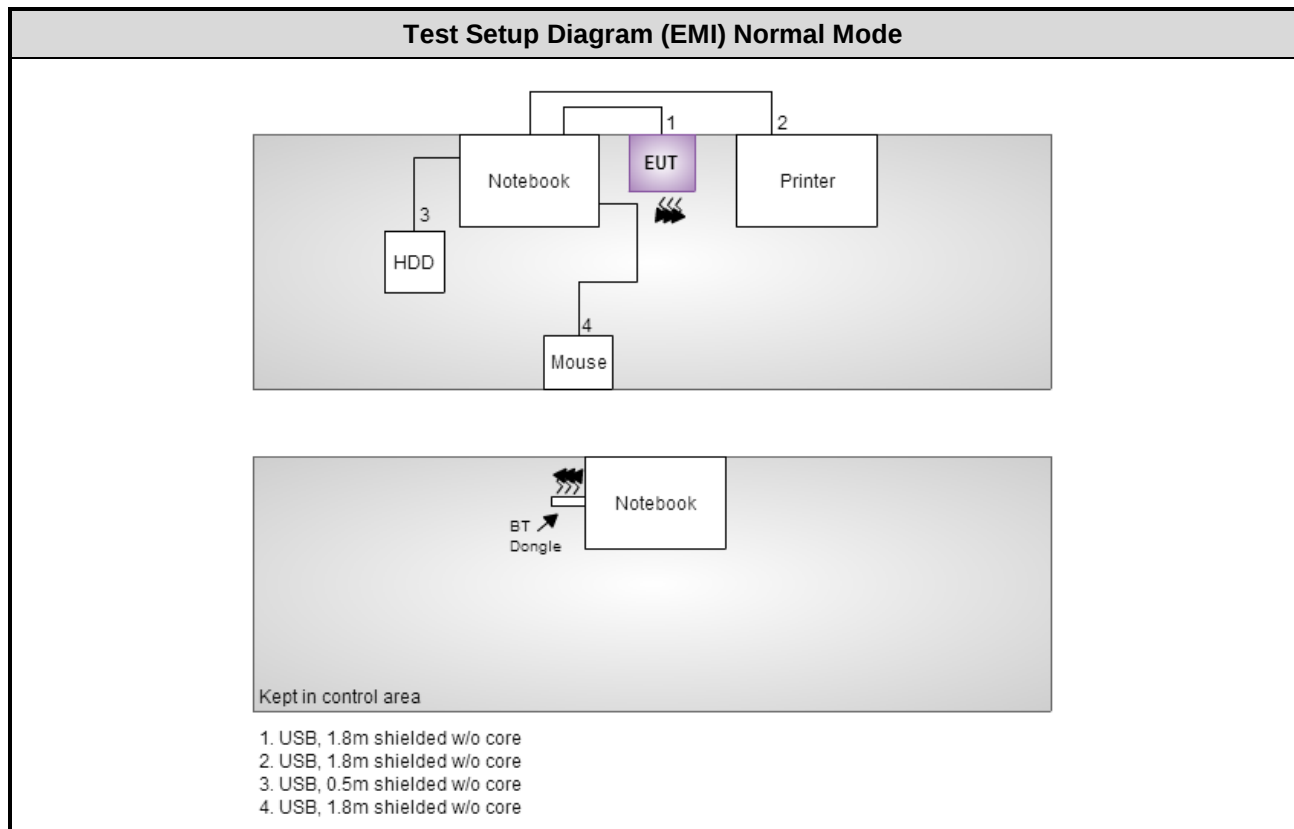
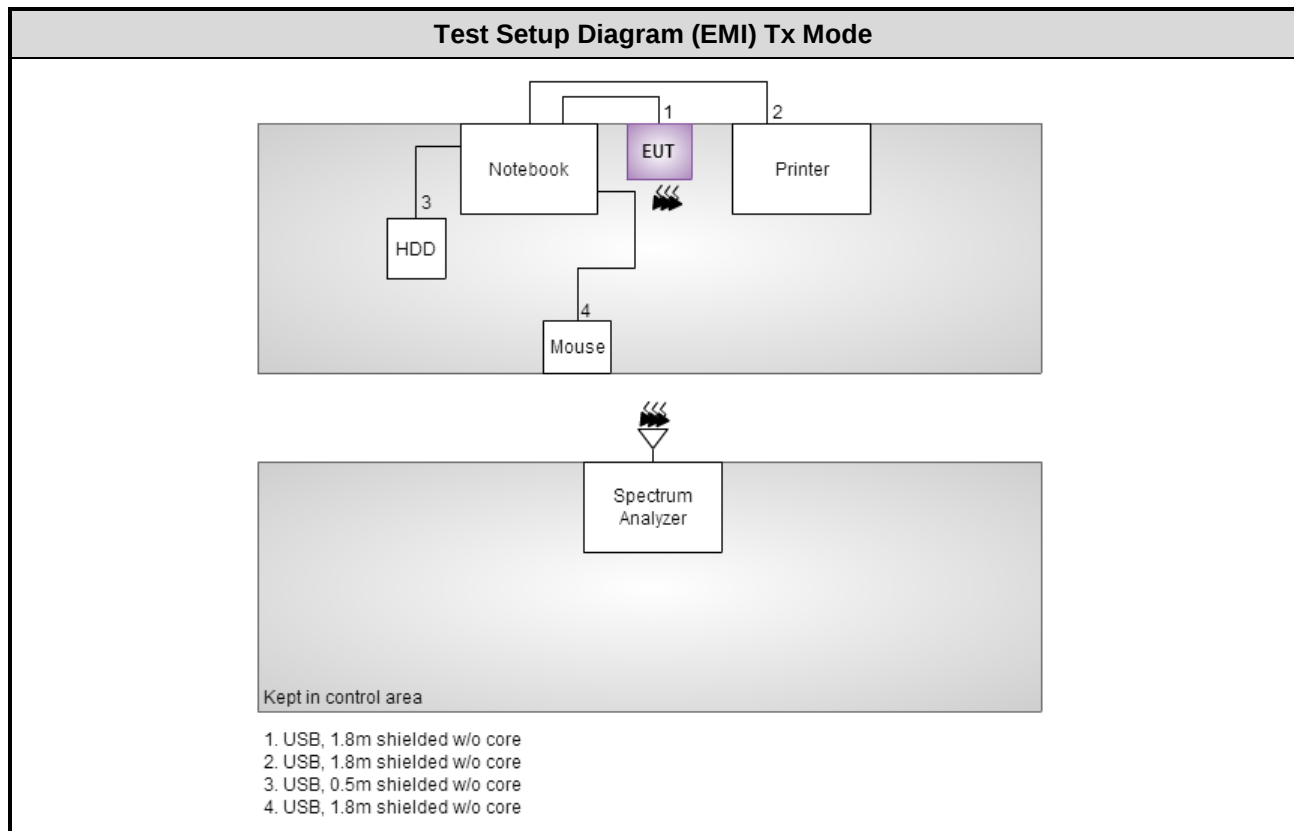
- 1) No. 6 was for Tx mode only.
- 2) No. 2 & 7 were for normal mode only
- 3) No. 7 was supplied by applicant.

Support Equipment List (EMS)					
No.	Equipment	Brand	Model	S/N	Signal cable / Length (m)
1	Notebook	DELL	Latitude E5430	6R4RWW1	---
2	Notebook	DELL	Latitude E5430	264RWW1	---
3	Spectrum Analyzer	ADVENTEST	R3132	130802566	---
4	BT 2.0 Dongle	Laird	BRBLU3-010 A0-03	AN1203955	---

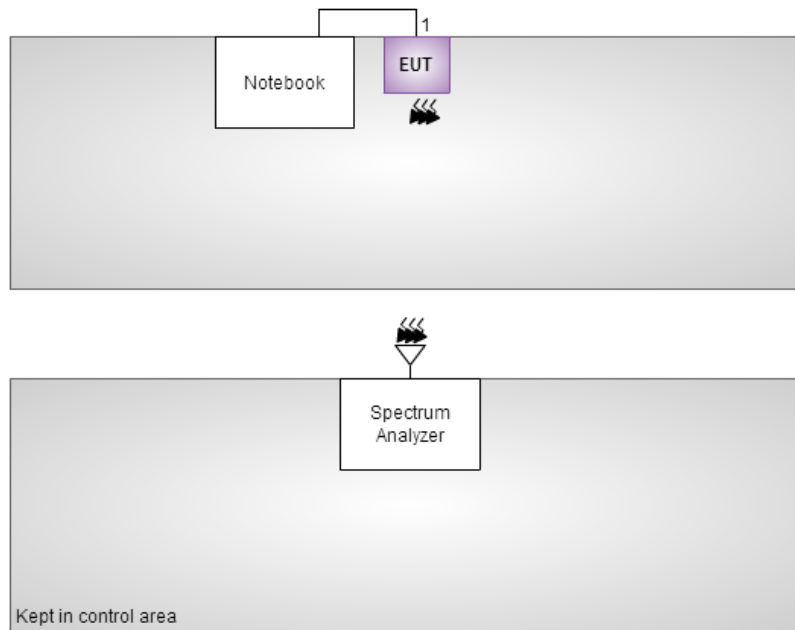
Note:

- 1) No. 3 was for Tx mode only.
- 2) No. 2 & 4 were for normal mode only
- 3) No. 4 was supplied by applicant.

2.4 Test Setup Chart

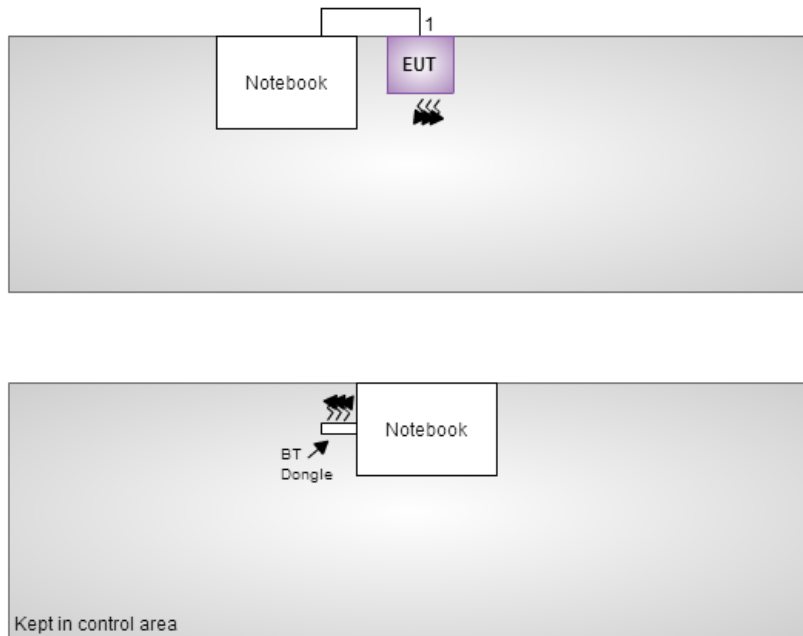


Test Setup Diagram (EMS) Tx Mode



1. USB, 1.8m shielded w/o core

Test Setup Diagram (EMS) Normal Mode



1. USB, 1.8m shielded w/o core

2.5 Test Software and Operating Condition

EMI_ Tx Mode

- a. To enable all function of test system.
- b. The support notebook ran “Bluesuite program.exe” to set EUT as Tx mode.
- c. The EUT transmitted BT signal continuously, and was received and monitored by spectrum.
- d. The support notebook ran “EMCTest.exe” to send “H” patterns to its monitor and the monitor displayed them.
- e. The support notebook ran “EMCTest.exe” to send “H” patterns to the printer.
- f. The support notebook ran “EMCTest.exe” to read and write data from HDD.

EMI_ Normal Mode

- a. To enable all function of test system.
- b. The support notebooks linked with each other via EUT and Bluetooth dongle by Bluetooth signal.
- c. The support notebooks ran “Teraterm.exe” to send “H” patterns to each other.
- d. The support notebook ran “EMCTest.exe” to send “H” patterns to its monitor and the monitor displayed them.
- e. The support notebook ran “EMCTest.exe” to send “H” patterns to the printer.
- f. The support notebook ran “EMCTest.exe” to read and write data from HDD.

EMS_ Tx Mode

- a. To enable all function of test system.
- b. The support notebook ran “Bluesuite program.exe” to set EUT as Tx mode.
- c. The EUT transmitted BT signal continuously, and was received and monitored by spectrum.

EMS_ Normal Mode

- a. To enable all function of test system.
- b. The support notebooks linked with each other via EUT and Bluetooth dongle by Bluetooth signal.
- c. The support notebooks ran “Teraterm.exe” to send “H” patterns to each other.

3 Emission Test Results

3.1 Conducted Emissions

3.1.1 Limit of Conducted Emissions

Frequency Range (MHz)	Class A (dBμV)		Class B (dBμV)	
	Limits			
	Quasi-peak	Average	Quasi-peak	Average
0.15 to 0.50	79	66	66 to 56	56 to 46
0.50 to 5	73	60	56	46
5 to 30	73	60	60	50

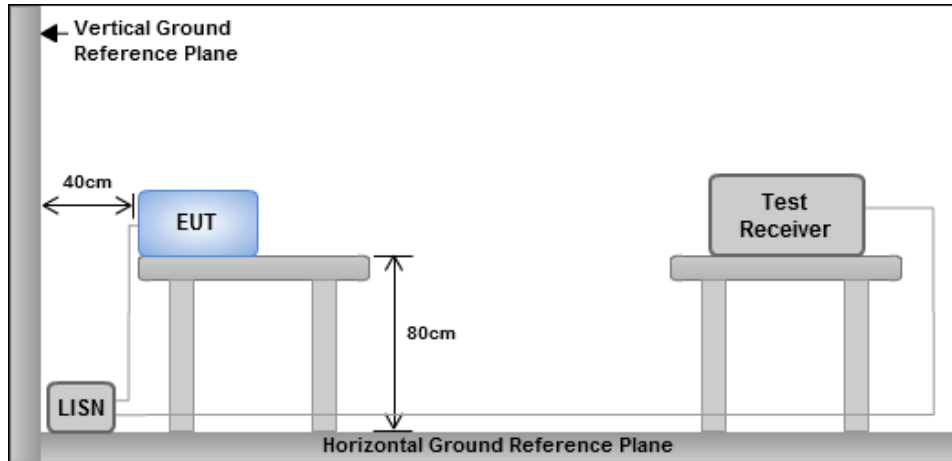
Note 1: The lower limit shall apply at the transition frequencies.

Note 2: The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

3.1.2 Test Procedures

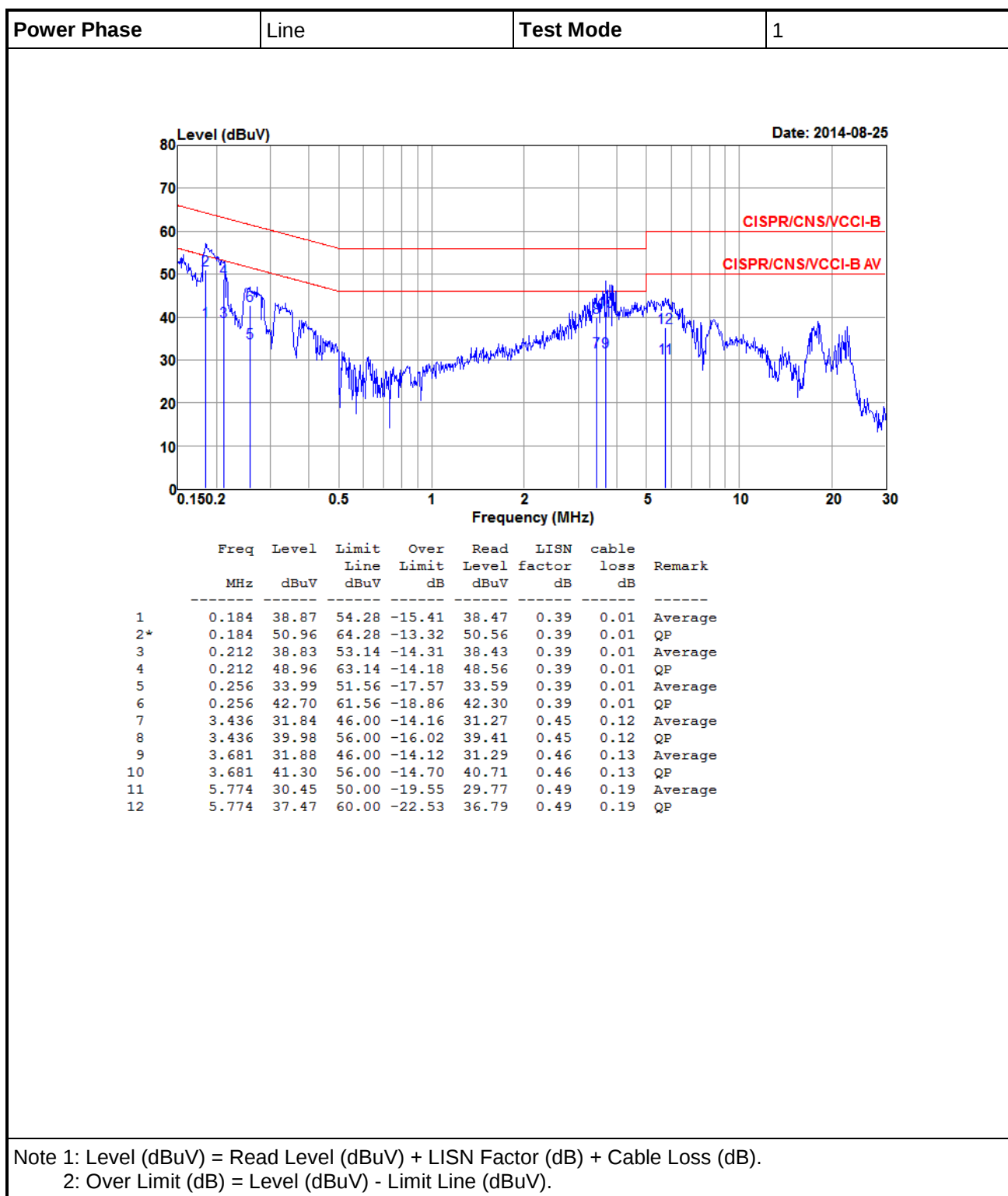
- The EUT was placed on a table with a height of 0.8 meters from the metal ground plane and 0.4 meters from the conducting wall of the shielding room and it was kept at least 0.8 meters from any other grounded conducting surface.
- The test equipment EUT installed received DC power through a Line Impedance Stabilization Network (LISN), which supplied power source and was grounded to the ground plane.
- All the support units were connected to the other LISN.
- The LISN provides 50 ohm coupling impedance for the measuring instrument.
- The CISPR states that a 50 ohm, 50 microhenry LISN should be used.
- Both sides of AC line were checked for maximum conducted interference.
- The measurement frequency range extends from 150 kHz to 30 MHz.
- Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

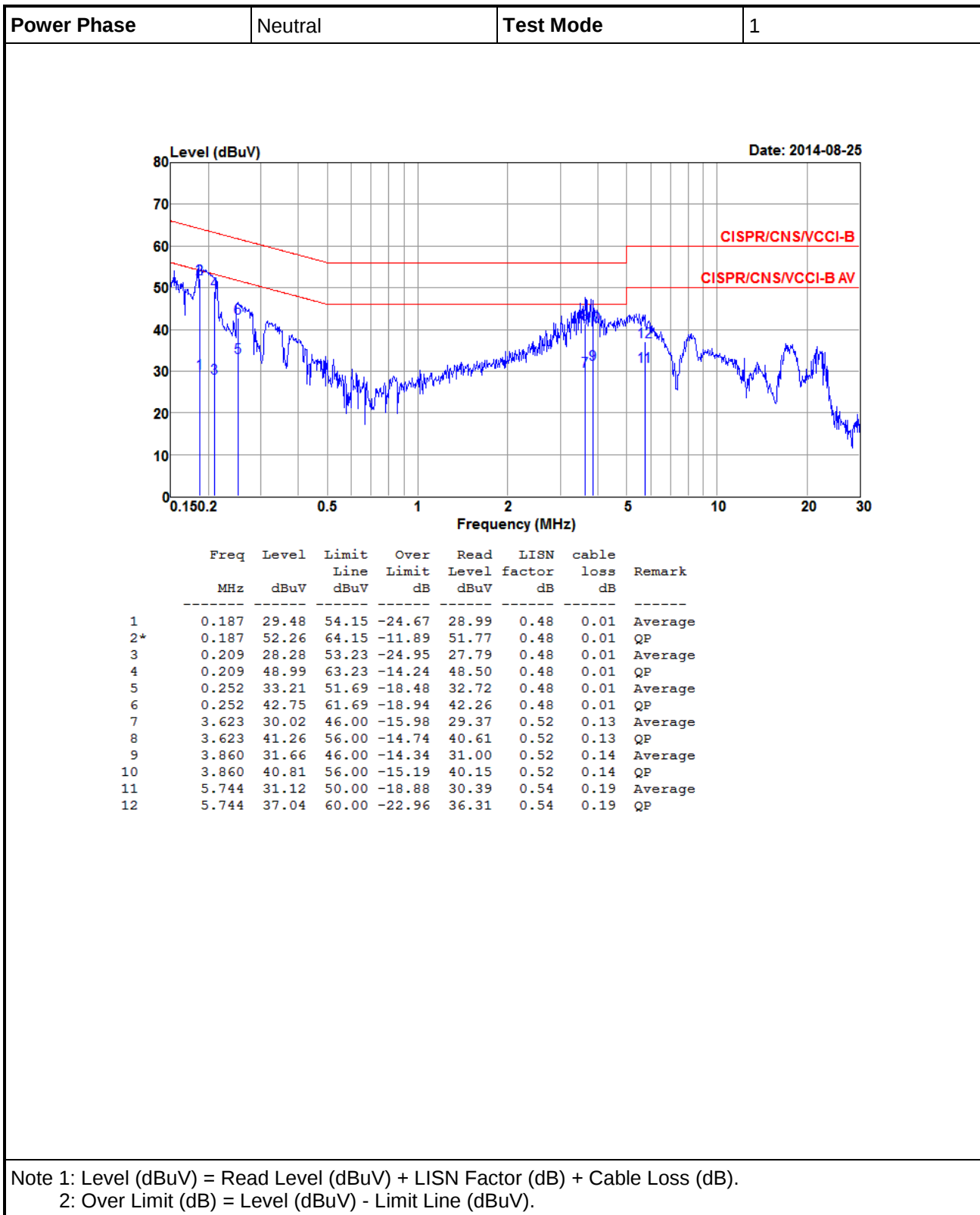
3.1.3 Test Setup

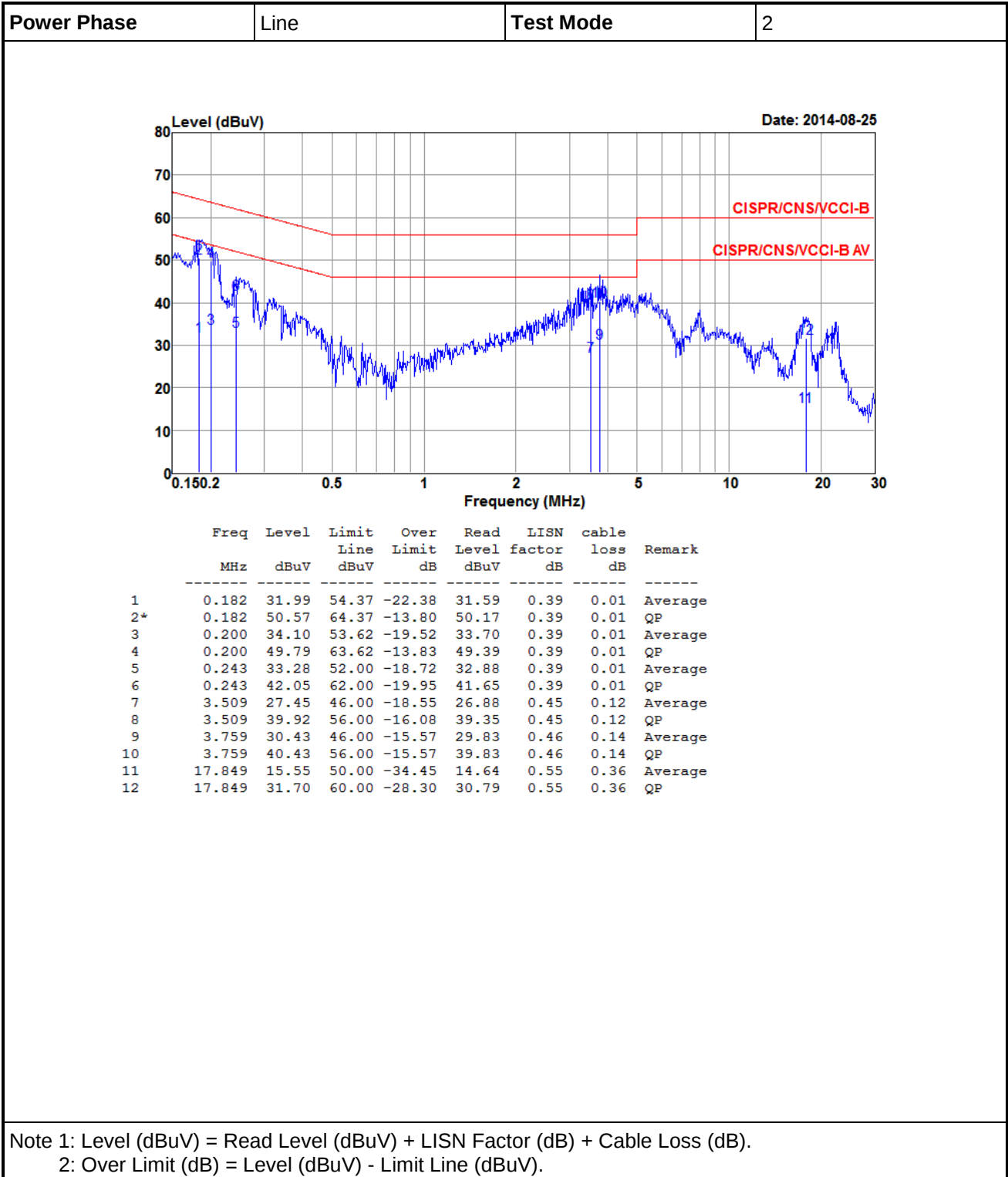


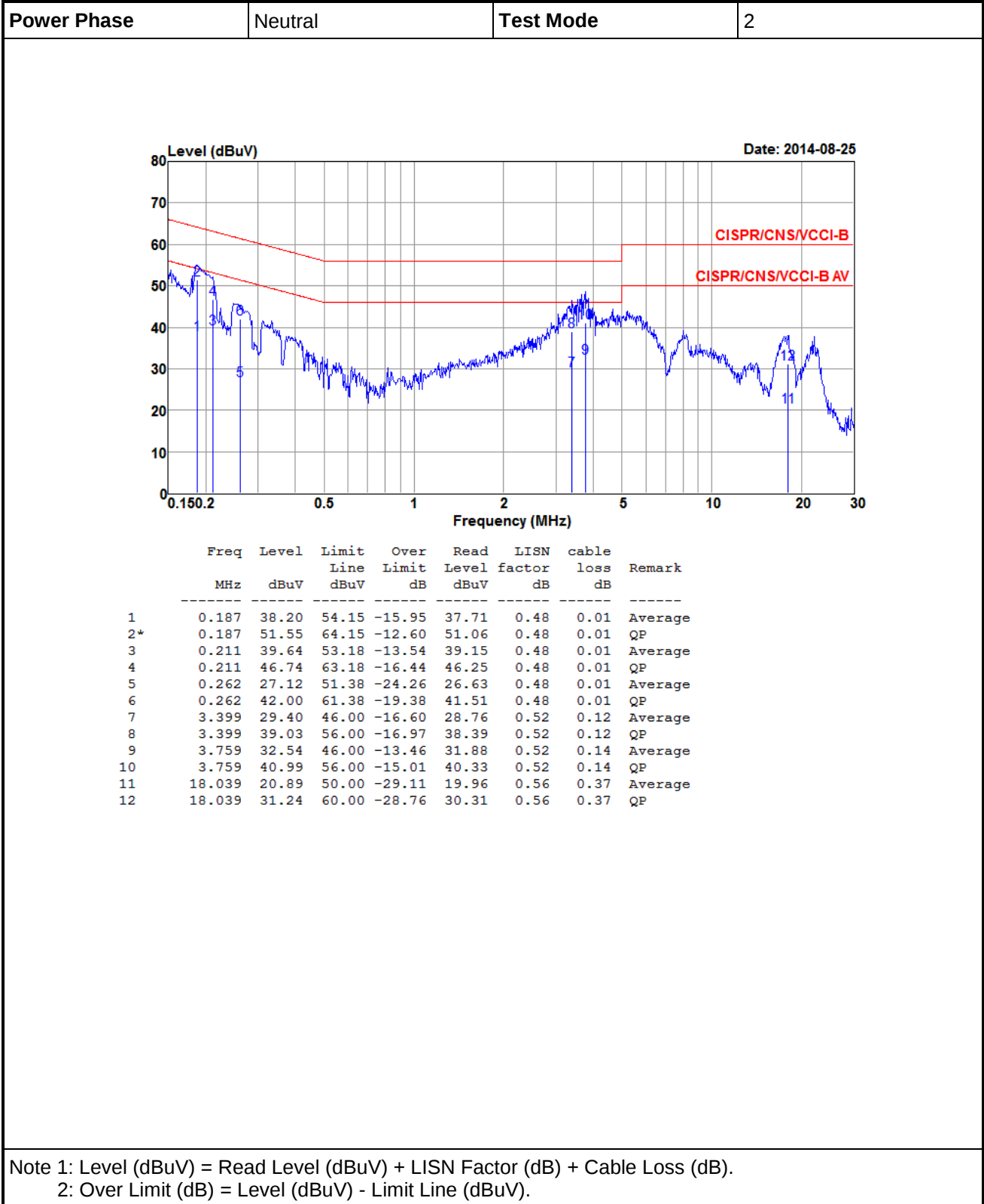
- Note: 1. Support units were connected to second LISN.
2. Both of LISNs (AMN) are 80 cm from EUT and at least 80 cm from other units and other metal planes

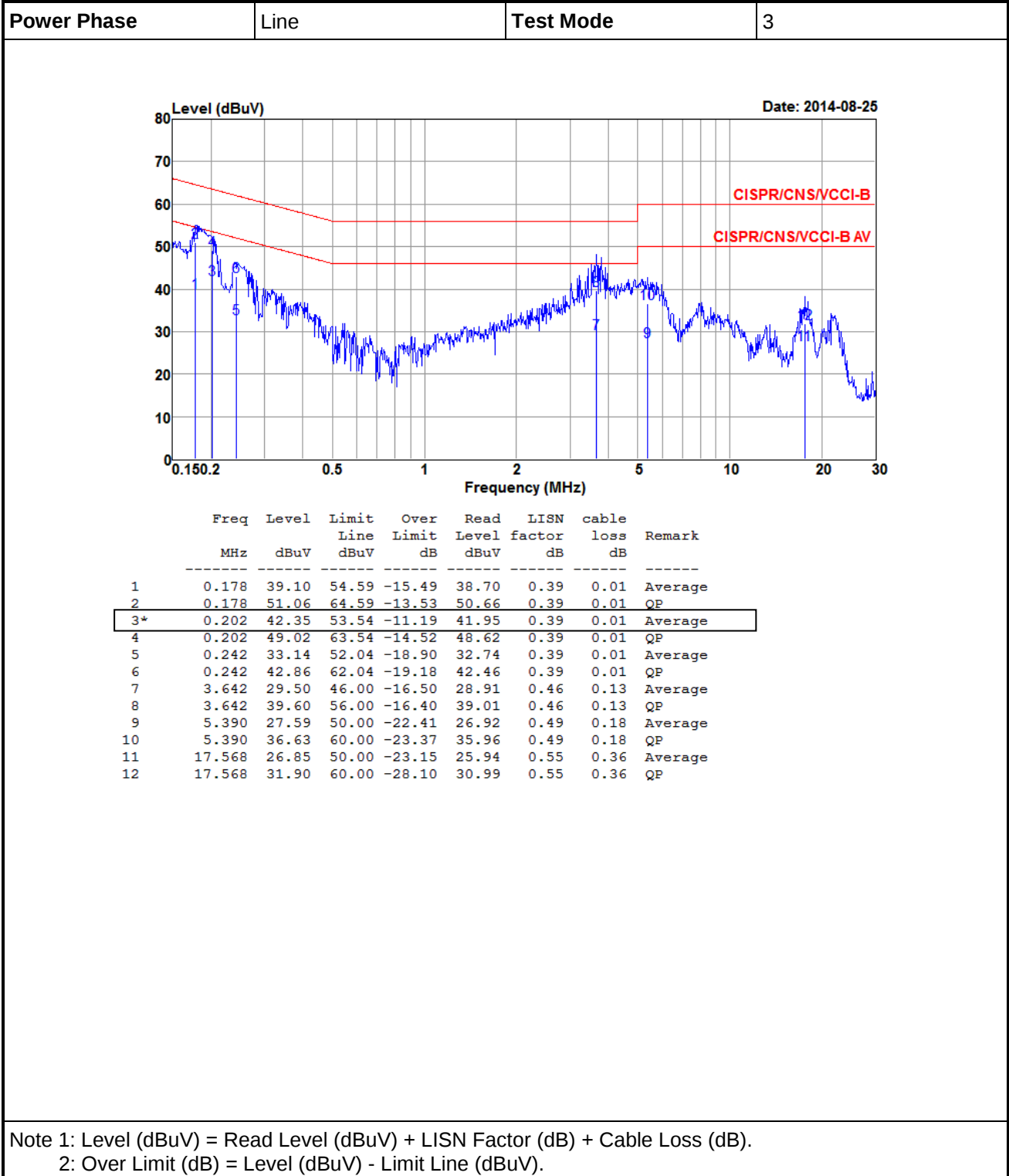
3.1.4 Test Result of Conducted Emissions

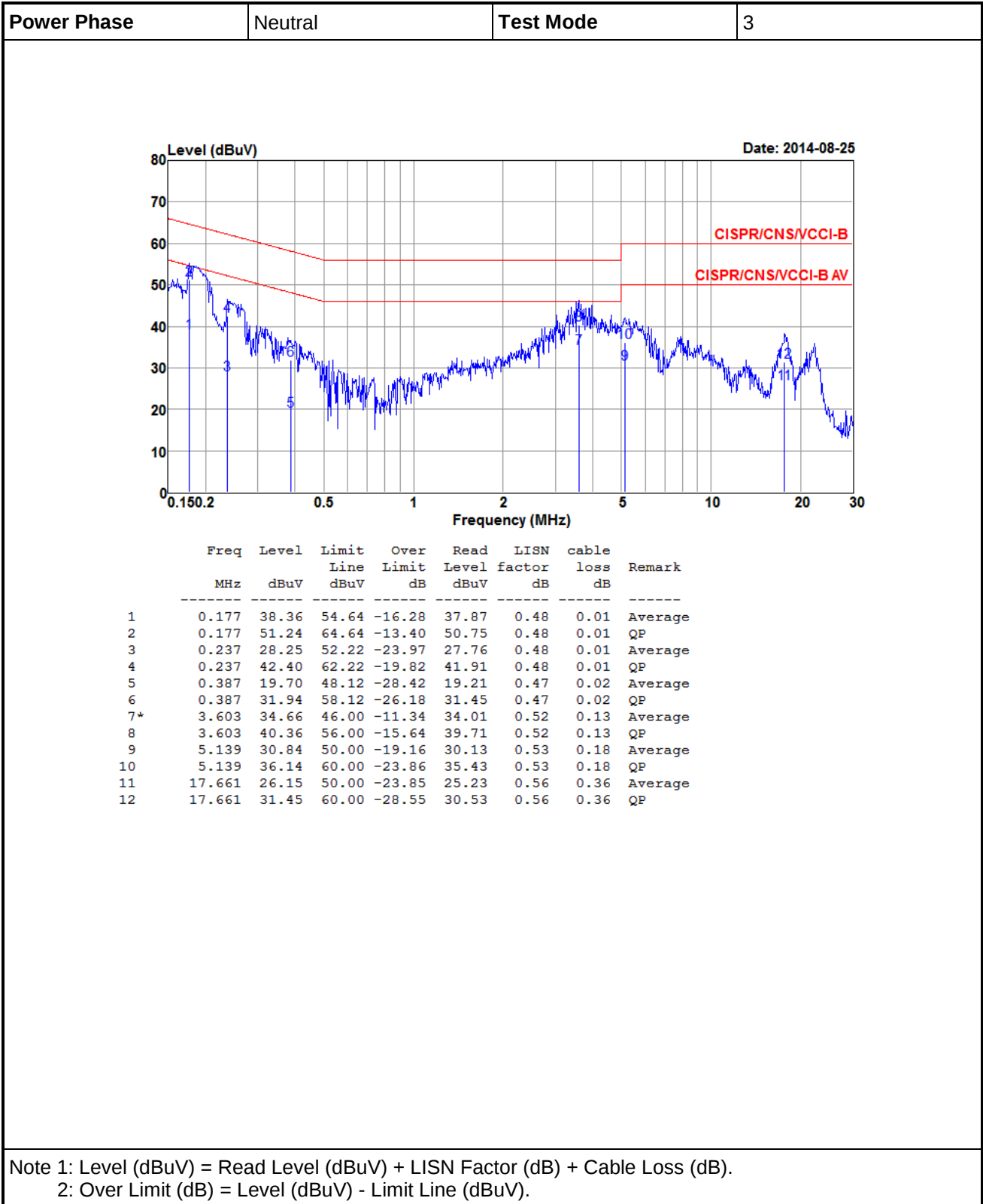


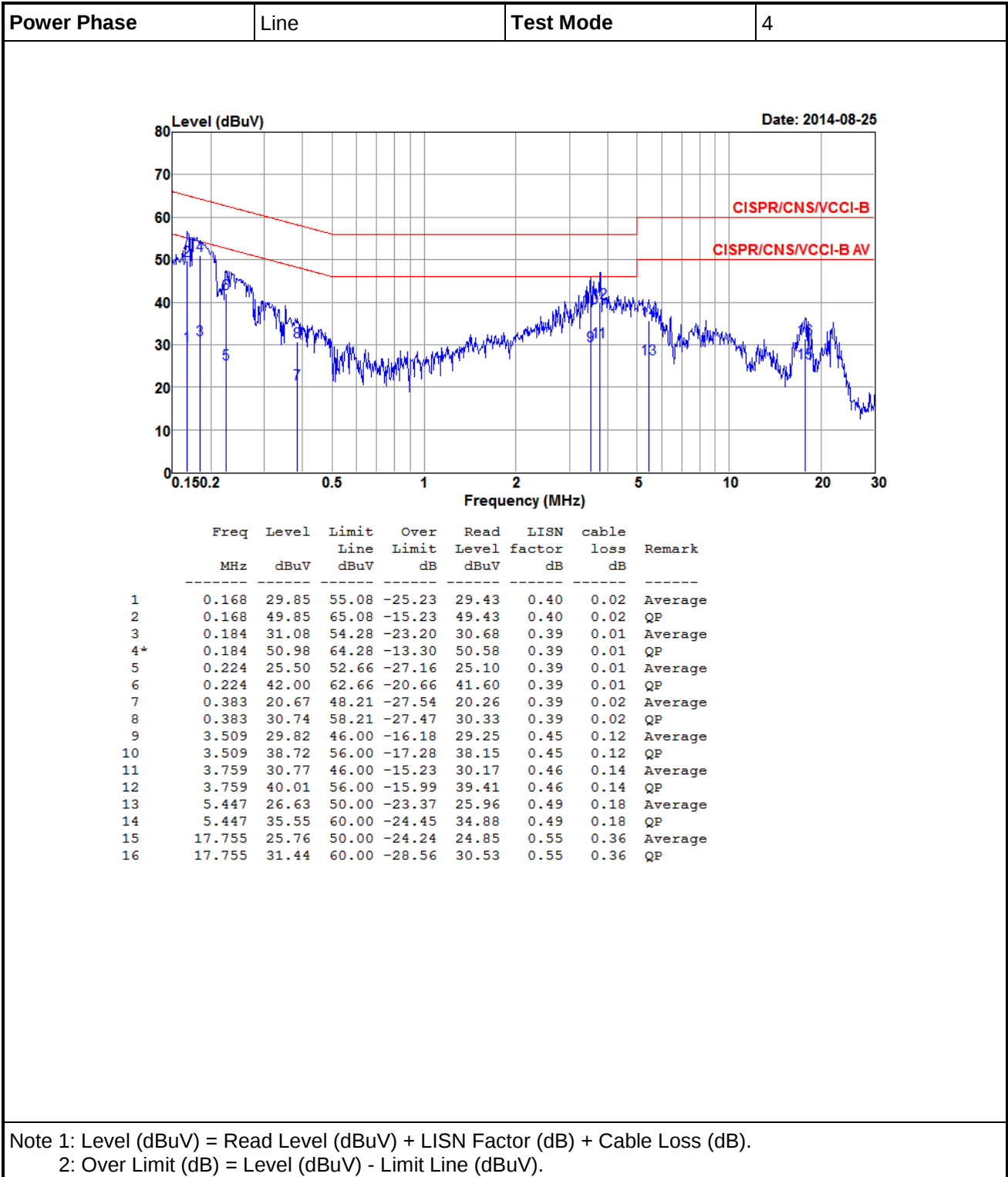


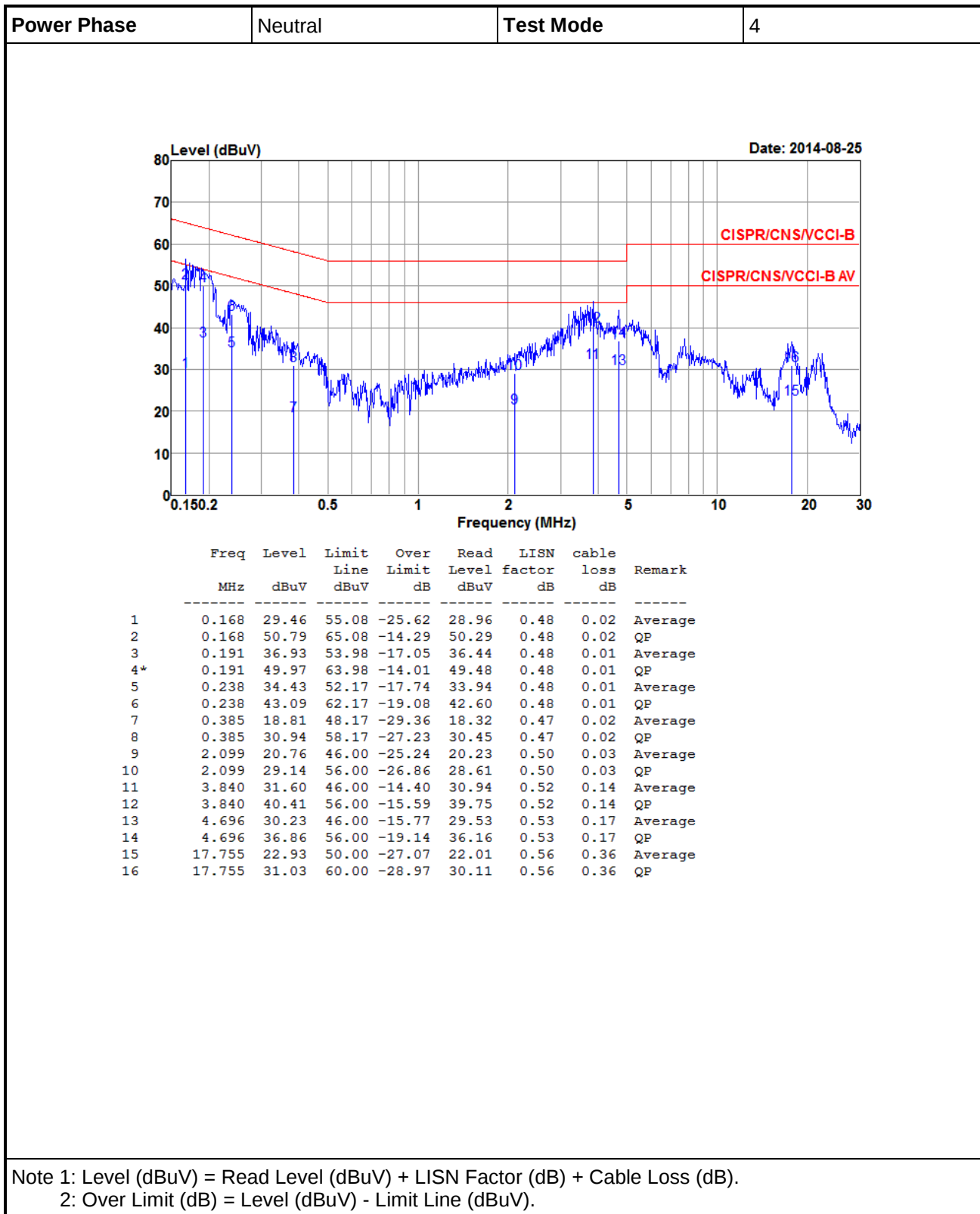


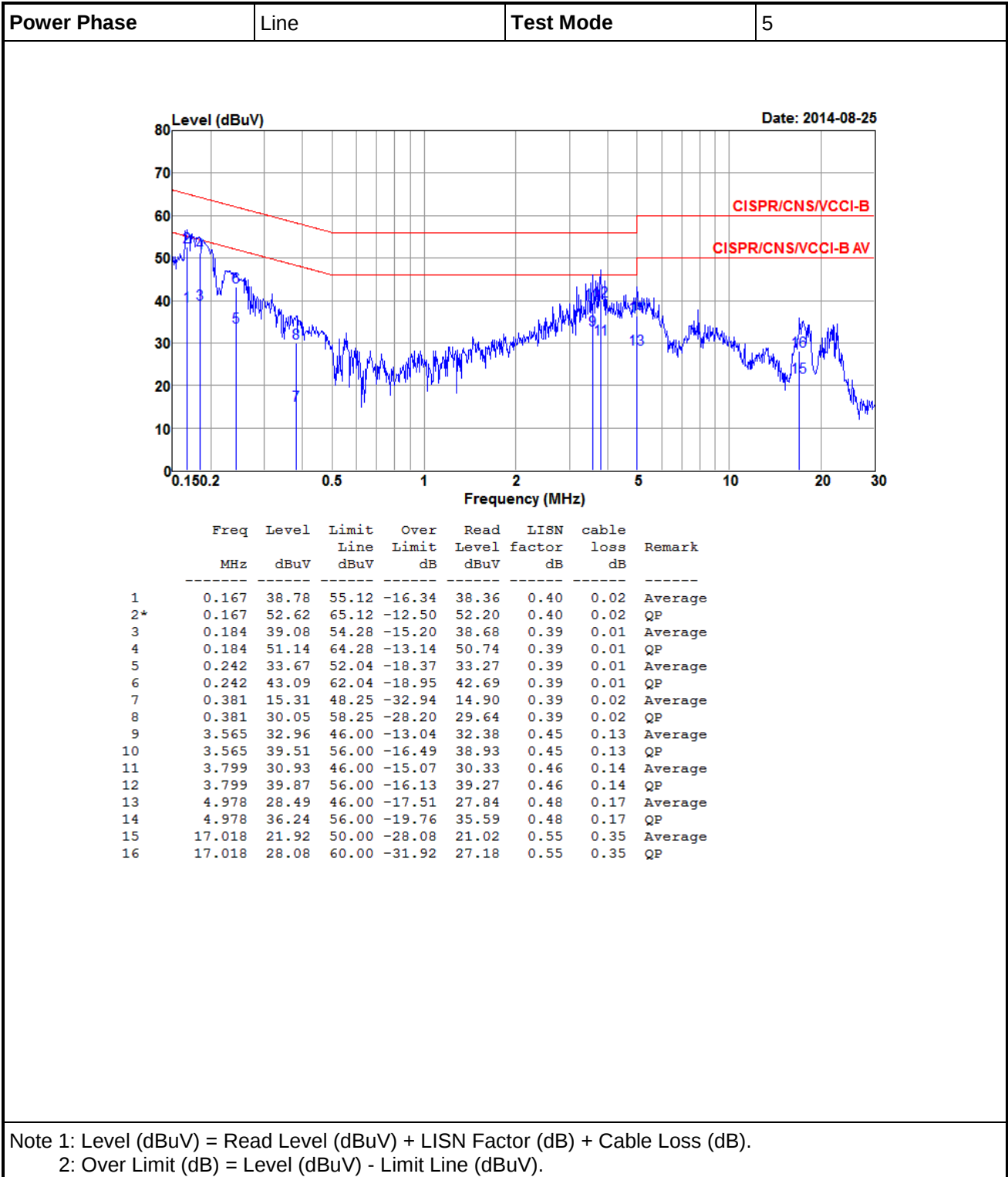








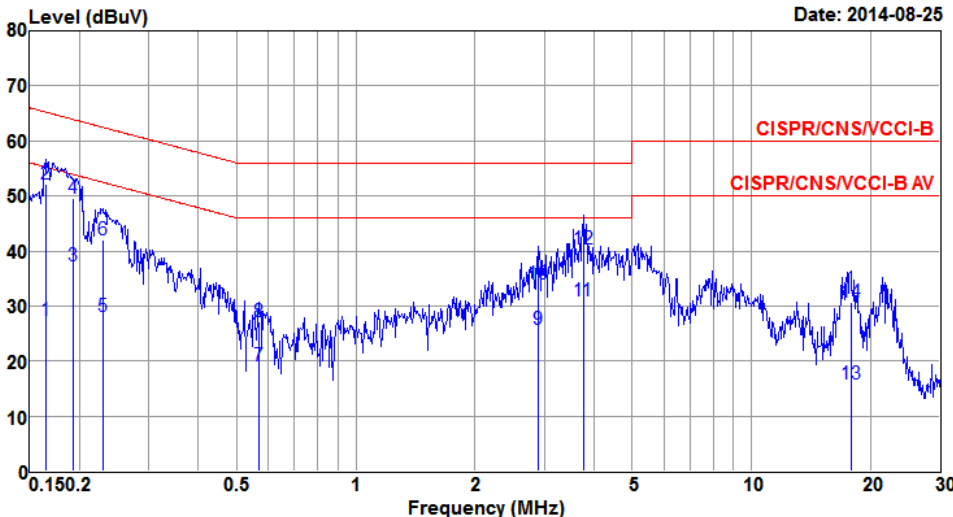




Power Phase	Neutral	Test Mode	5
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Level (dBuV)

Date: 2014-08-25



Frequency (MHz)

	Freq MHz	Level dBuV	Limit Line dBuV	Over Limit dB	Read Level dBuV	LISN factor dB	cable loss dB	Remark
1	0.164	27.44	55.25	-27.81	26.94	0.48	0.02	Average
2*	0.164	52.27	65.25	-12.98	51.77	0.48	0.02	QP
3	0.193	37.32	53.89	-16.57	36.83	0.48	0.01	Average
4	0.193	49.53	63.89	-14.36	49.04	0.48	0.01	QP
5	0.229	28.14	52.48	-24.34	27.65	0.48	0.01	Average
6	0.229	42.12	62.48	-20.36	41.63	0.48	0.01	QP
7	0.567	19.21	46.00	-26.79	18.65	0.47	0.09	Average
8	0.567	27.05	56.00	-28.95	26.49	0.47	0.09	QP
9	2.900	25.81	46.00	-20.19	25.21	0.51	0.09	Average
10	2.900	34.02	56.00	-21.98	33.42	0.51	0.09	QP
11	3.759	30.94	46.00	-15.06	30.28	0.52	0.14	Average
12	3.759	40.31	56.00	-15.69	39.65	0.52	0.14	QP
13	17.849	15.76	50.00	-34.24	14.84	0.56	0.36	Average
14	17.849	30.61	60.00	-29.39	29.69	0.56	0.36	QP

Note 1: Level (dBuV) = Read Level (dBuV) + LISN Factor (dB) + Cable Loss (dB).

Note 2: Over Limit (dB) = Level (dBuV) - Limit Line (dBuV).

4 Immunity Tests

4.1 General Description

Product Standard: EN 301 489-1, EN 301 489-17		
Basic Standard	Spec. Requirement	Performance Criteria
EN 61000-4-2 (ESD)	Contact Discharge: ± 4 kV Air Discharge: ± 8 kV	B
EN 61000-4-3 (RS)	80-1000 MHz, 1400-2700 MHz 3 V/m, 1 kHz Sine Wave 80%, AM Modulation	A

4.2 Performance Criteria Description

Performance Criteria	
Performance criteria for Continuous phenomena applied to Transmitters (CT)	The performance criteria A shall apply.
Performance criteria for Transient phenomena applied to Transmitters (TT)	The performance criteria B shall apply.
Performance criteria for Continuous phenomena applied to Receivers (CR)	The performance criteria A shall apply.
Performance criteria for Transient phenomena applied to Receivers (TR)	The performance criteria B shall apply.

Performance Table		
Criteria	During test	After test
A	Shall operate as intended. May show degradation of performance (see note1). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended. Shall be no degradation of performance (see note 2). Shall be no loss of function. Shall be no loss of stored data or user programmable functions.
B	May show loss of function (one or more). May show degradation of performance (see note 1). No unintentional transmissions.	Functions shall be self-recoverable. Shall operate as intended after recovering. Shall be no degradation of performance (see note 2). Shall be no loss of stored data or user programmable functions.
C	May be loss of function (one or more).	Functions shall be recoverable by the operator. Shall operate as intended after recovering. Shall be no degradation of performance (see note 2).
Note 1:	Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.	
Note 2:	No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed. If the minimum performance level or the permissible performance degradation is not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect from the apparatus if used as intended.	

4.3 Electrostatic Discharge (ESD)

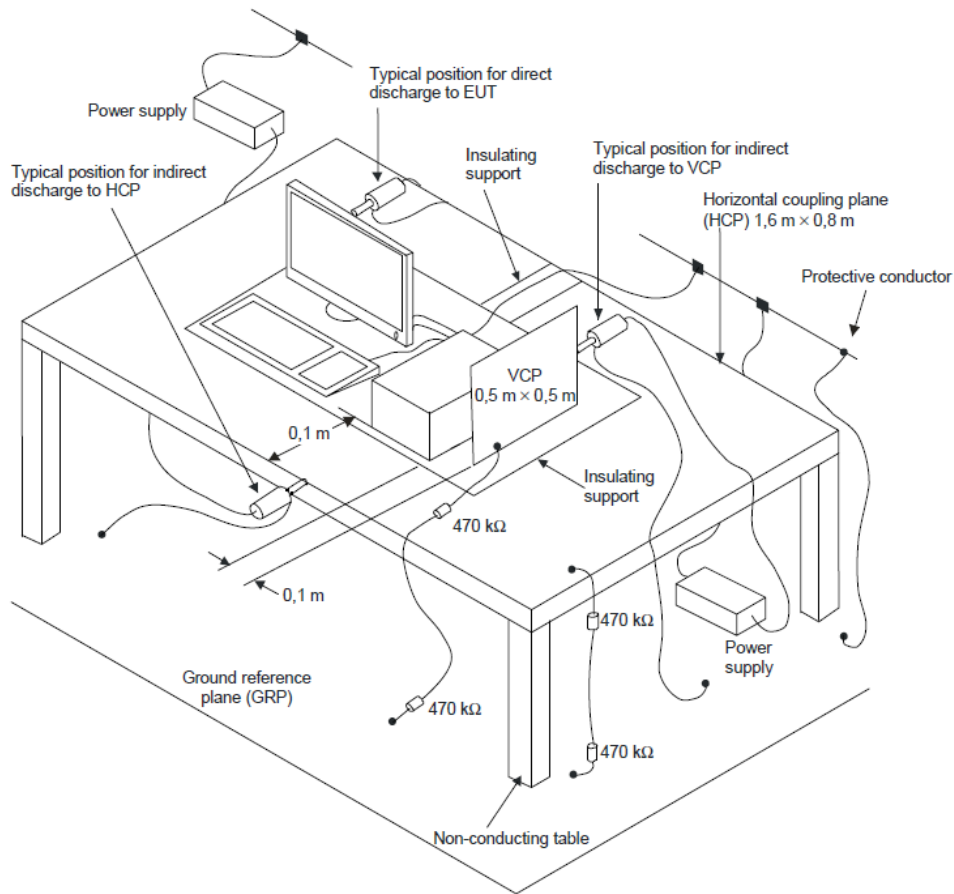
4.3.1 Test Specification of Electrostatic Discharge (ESD)

Basic Standard	EN 61000-4-2
Discharge Voltage	Contact Discharge: ± 2 kV / ± 4 kV Air Discharge: ± 2 kV / ± 4 kV / ± 8 kV
Discharge Impedance	330 ohm / 150 pF
Number of Discharge	Air Discharge: minimum 20 times at each test point Contact Discharge: minimum 20 times at each test point
Discharge Mode	Single Discharge
Discharge Period	1 second minimum

4.3.2 Test Procedures

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
 - ambient temperature: 15°C to 35°C;
 - relative humidity : 30% to 60%;
 - atmospheric pressure : 86 kPa (860 mbar) to 106 kPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On preselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On preselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be determined whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted:
 - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
 - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
 - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

4.3.3 Test Setup



The test setup shall consist of a non-conductive table, (0.8 ± 0.08) m high, standing on the ground reference plane.

A horizontal coupling plane (HCP), (1.6 ± 0.02) m $\times$ (0.8 ± 0.02) m, shall be placed on the table. The EUT and its cables shall be isolated from the coupling plane by an insulating support (0.5 ± 0.05) mm in thickness.

4.3.4 Test Result of Electrostatic Discharge (ESD)

Test Mode	1, 3				
Direct Application					
Test Point	Polarity	Test Voltage (kV)	Contact Discharge	Air Discharge	Performance Criteria
1	+/-	2, 4	Note	N/A	A
2	+/-	2, 4, 8	N/A	Note	A
Indirect Application					
Test Point	Polarity	Test Voltage (kV)	Horizontal Coupling Plane (HCP)	Vertical Coupling Plane (VCP)	Performance Criteria
At front, rear, left and right side	+/-	2, 4	Note	Note	A

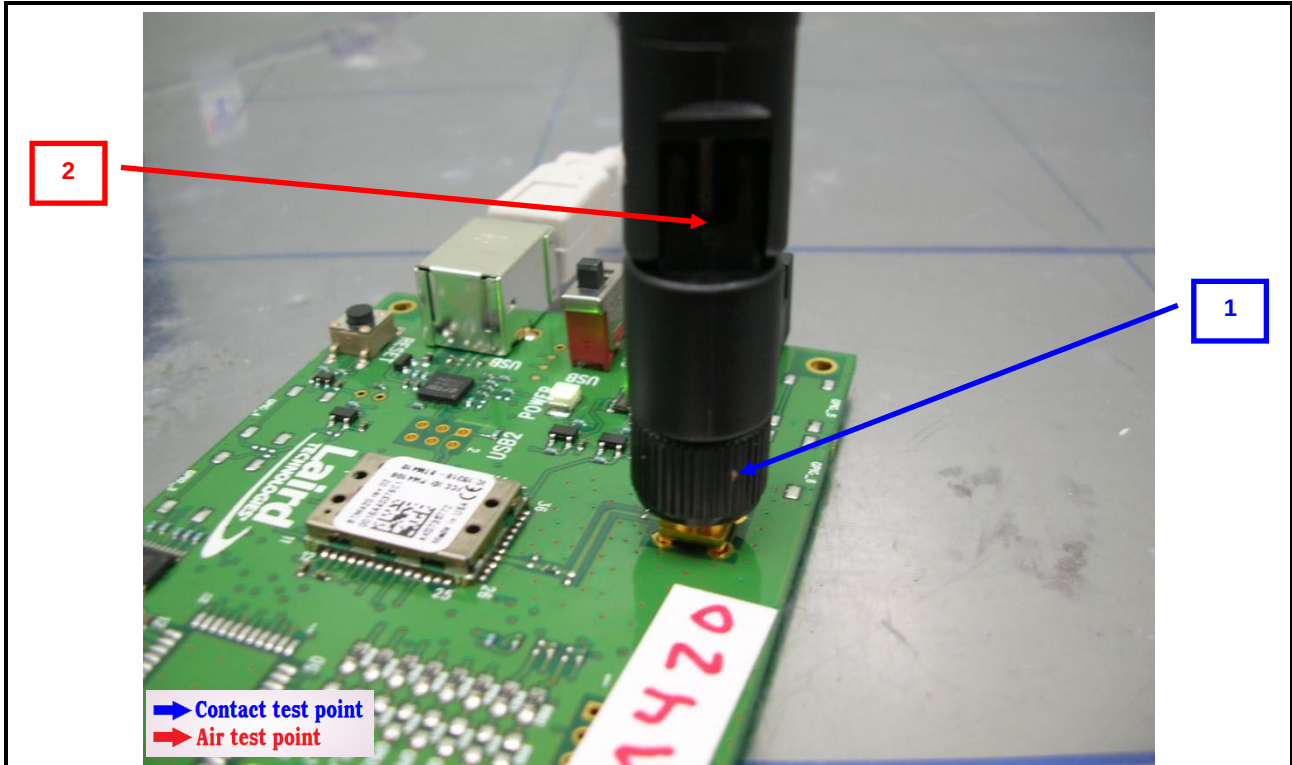
Note: There was no abnormal situation during the test compared with initial operation.

Test Mode	2, 4, 5				
Indirect Application					
Test Point	Polarity	Test Voltage (kV)	Horizontal Coupling Plane (HCP)	Vertical Coupling Plane (VCP)	Performance Criteria
At front, rear, left and right side	+/-	2, 4	Note	Note	A

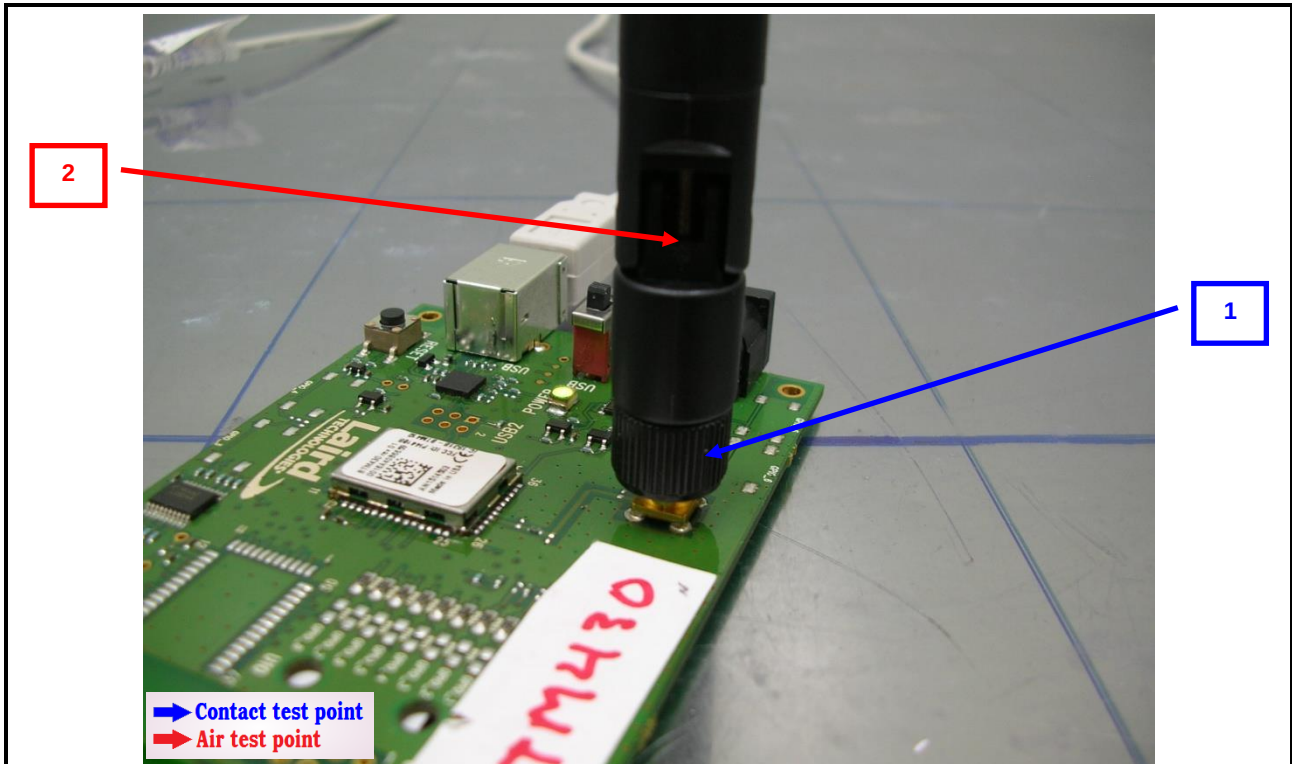
Note: There was no abnormal situation during the test compared with initial operation.

4.3.5 Test Point Photo

Mode 1



Mode 3



4.4 Radio Frequency Electromagnetic Field (RS)

4.4.1 Test Specification of Radio Frequency Electromagnetic Field (RS)

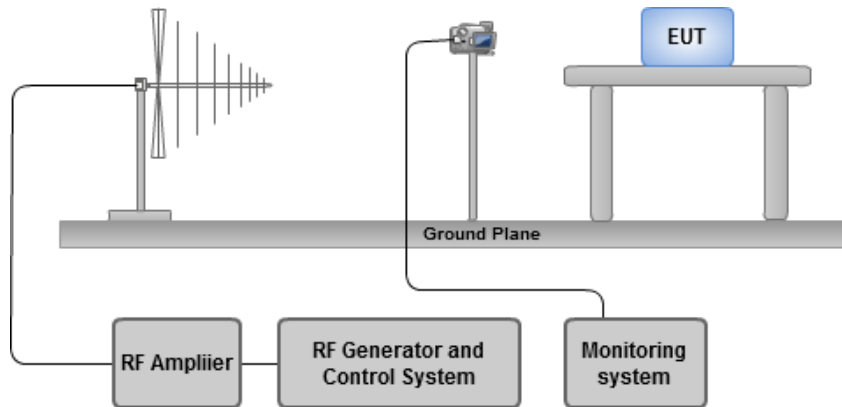
Basic Standard	EN 61000-4-3
Frequency Range	80 MHz ~ 1000 MHz, 1400 MHz to 2700 MHz
Field Strength	3 V/m
Modulation	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step	1 % of preceding frequency value
Polarity of Antenna	Horizontal and Vertical
Antenna Height	1.5 m
Dwell Time	3 seconds

Note: The exclusion band for the transmitter and / or receiver part of the 2.48 GHz WLAN equipment under test shall extend from 2280 MHz to 2607.675 MHz.

4.4.2 Test Procedures

- The test level shall be 3 V/m (measured unmodulated). The test signal shall be amplitude modulated to a depth of 80 % by a sinusoidal audio signal of 1000 Hz. If the wanted signal is modulated at 1000 Hz, then an audio signal of 400 Hz shall be used.
- The test shall be performed over the frequency range 80 MHz to 1000 MHz & 1400MHz to 2700MHz with the exception of the exclusion band for transmitters, receivers and duplex transceivers, as appropriate.
- For receivers and transmitters the stepped frequency increments shall be 1 % frequency increment of the momentary used frequency, unless specified otherwise in the part of EN 301 489 series [i.13] dealing with the relevant type of radio equipment.
- Further product related spot frequency tests may be specified in the relevant part of EN 301 489 series [i.13] dealing with the particular type of radio equipment.
- Responses on receivers occurring at discrete frequencies, which are narrow band responses, shall be disregarded from the test.
- The frequencies selected and used during the test shall be recorded in the test report.

4.4.3 Test Setup



Note: The procedure defined in this part requires the generation of electromagnetic fields within which the test sample is placed and its operation observed. To generate fields that are useful for simulation of actual (field) conditions may require significant antenna drive power and the resultant high field strength levels. To comply with local regulations and to prevent biological hazards to the testing personnel, it is recommended that these tests be carried out in a shielded enclosure or semi-anechoic chamber.

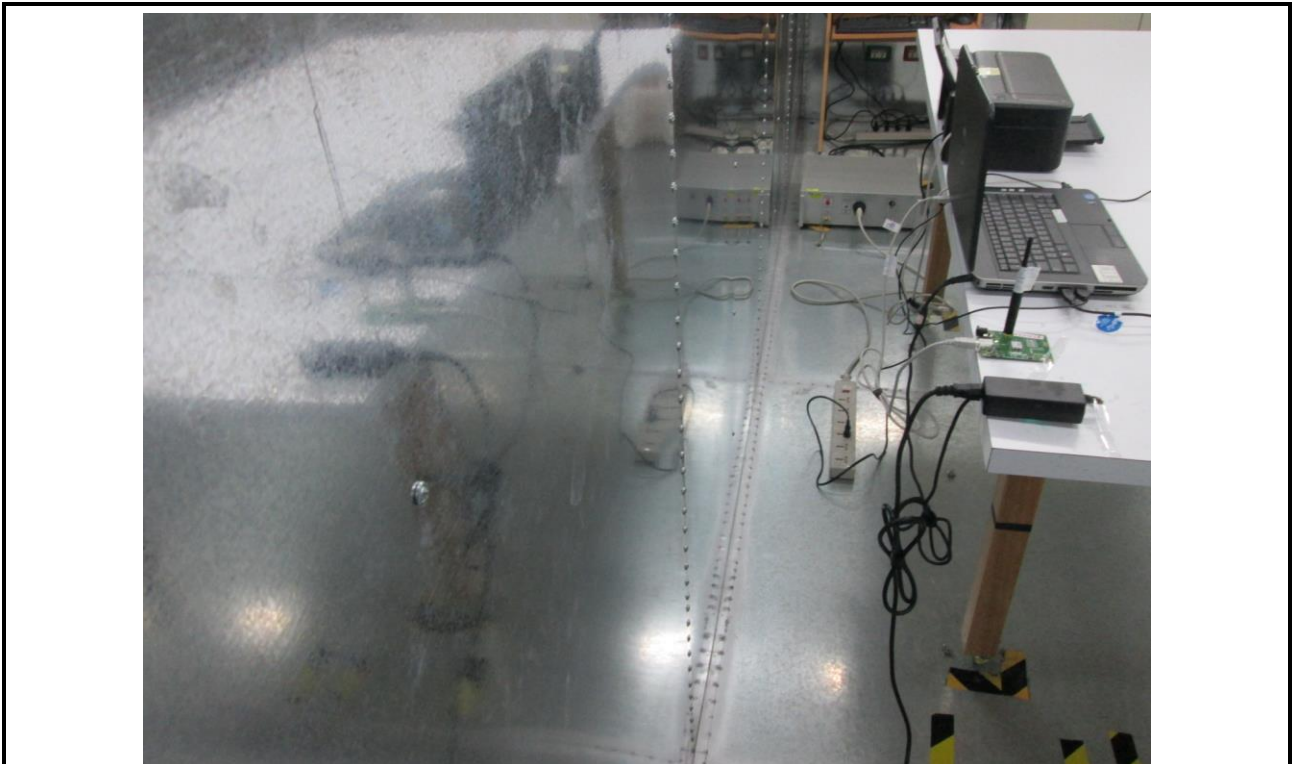
4.4.4 Test Result of Radio Frequency Electromagnetic Field (RS)

Test Mode	1, 2, 3, 4, 5				
Frequency Range (MHz)	Azimuth	Polarity	Test Field Strength (V/m)	Observation	Performance Criteria
80 – 1000	0	V&H	3	Note	A
80 – 1000	90	V&H	3	Note	A
80 – 1000	180	V&H	3	Note	A
80 – 1000	270	V&H	3	Note	A
1400 – 2700	0	V&H	3	Note	A
1400 – 2700	90	V&H	3	Note	A
1400 – 2700	180	V&H	3	Note	A
1400 – 2700	270	V&H	3	Note	A

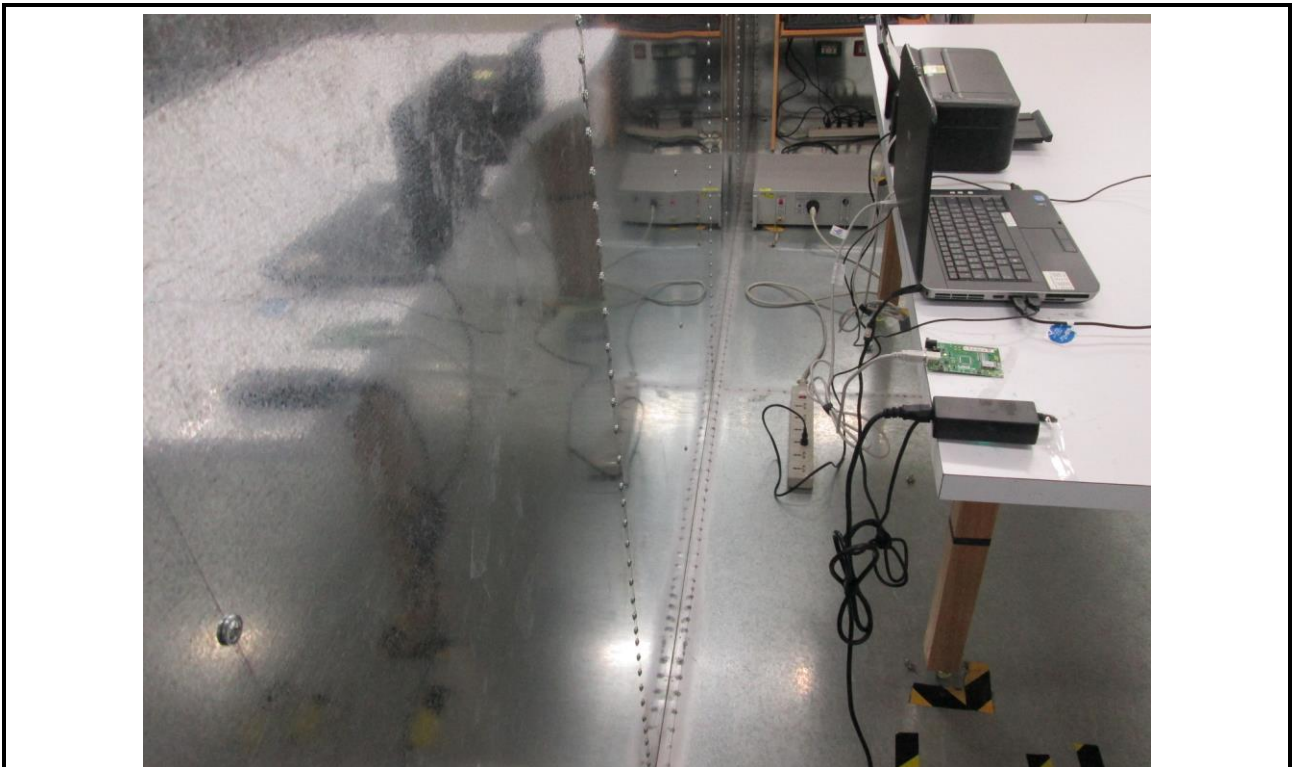
Note: There was no abnormal situation during the test compared with initial operation.

5 Photographs of the Test Configuration

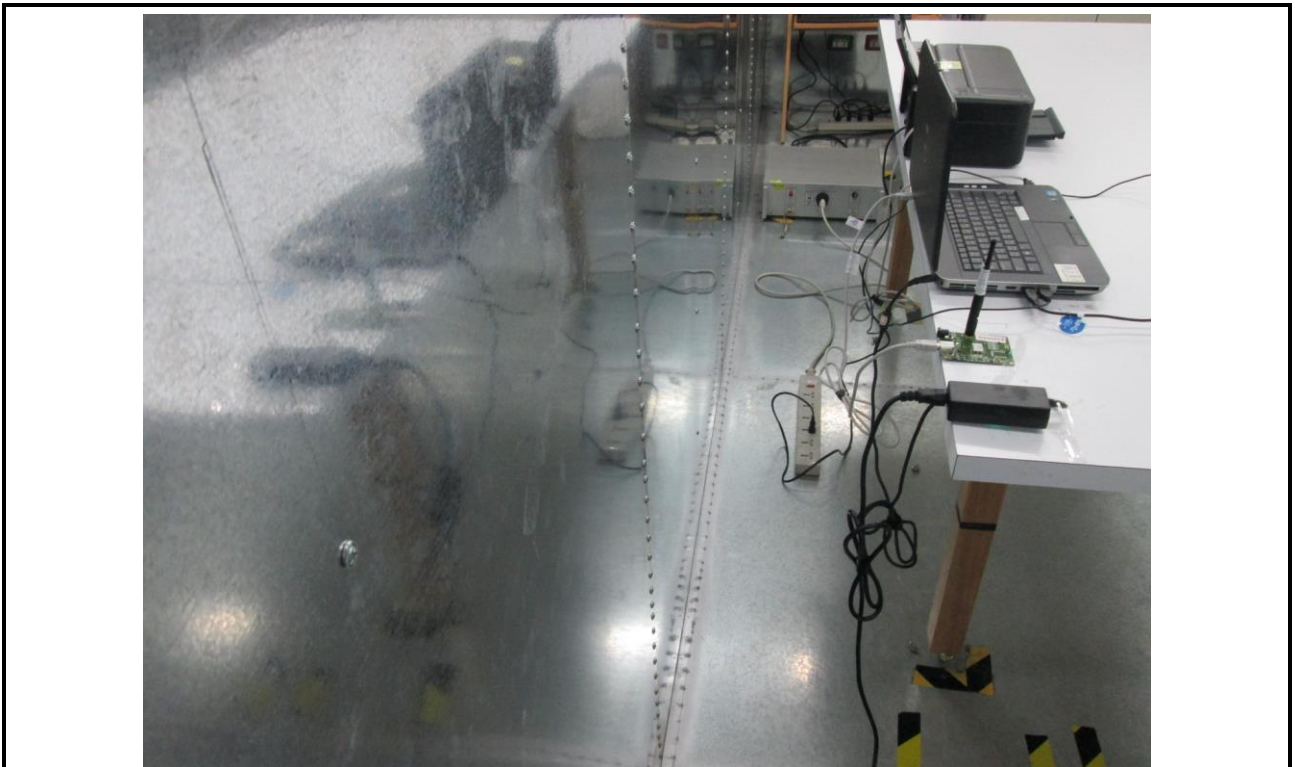
Conducted Emission Test (Mode 1)



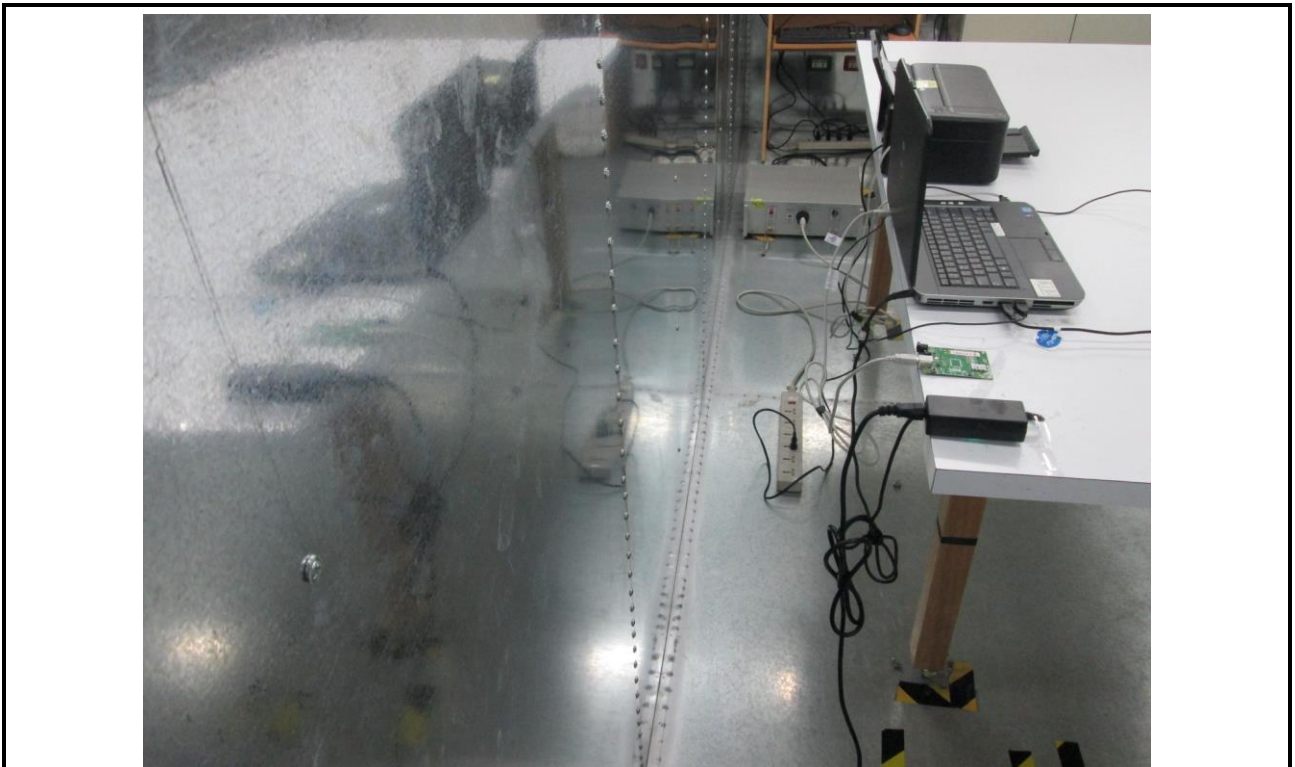
Conducted Emission Test (Mode 2)



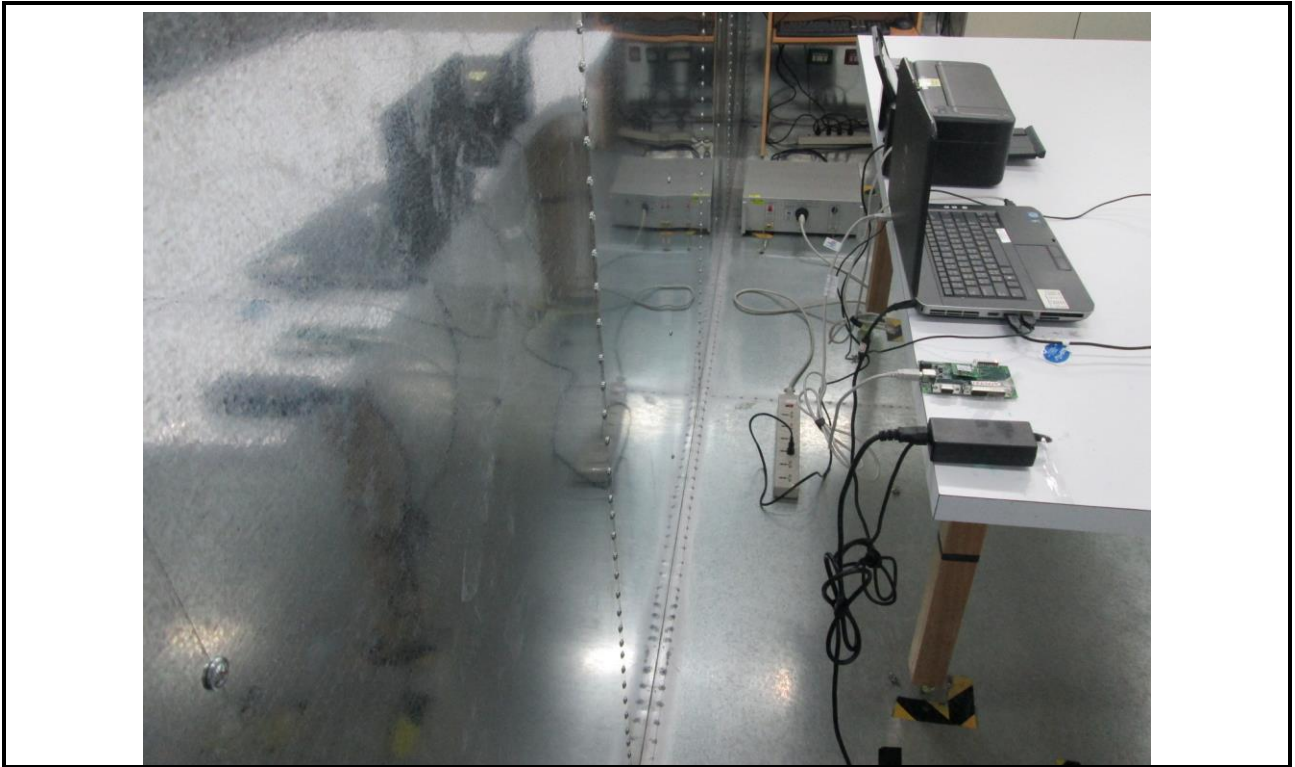
Conducted Emission Test (Mode 3)



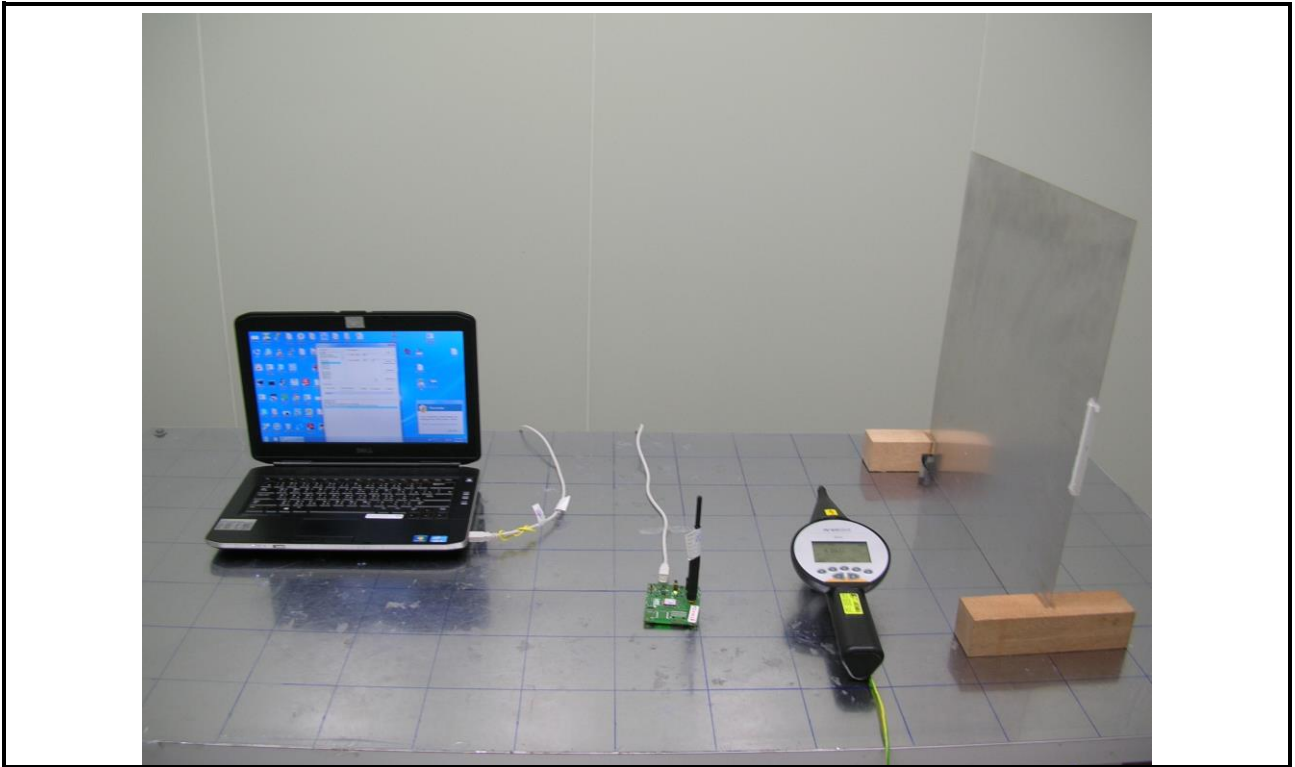
Conducted Emission Test (Mode 4)



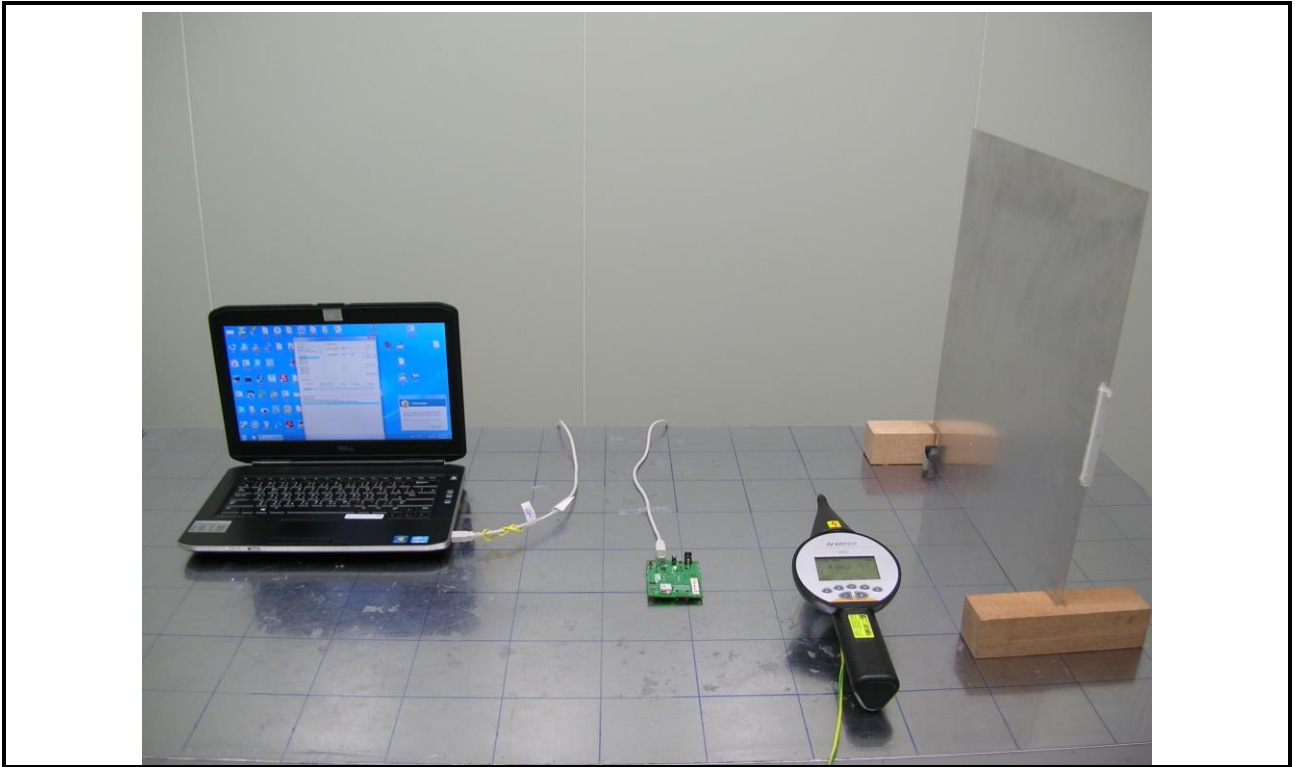
Conducted Emission Test (Mode 5)



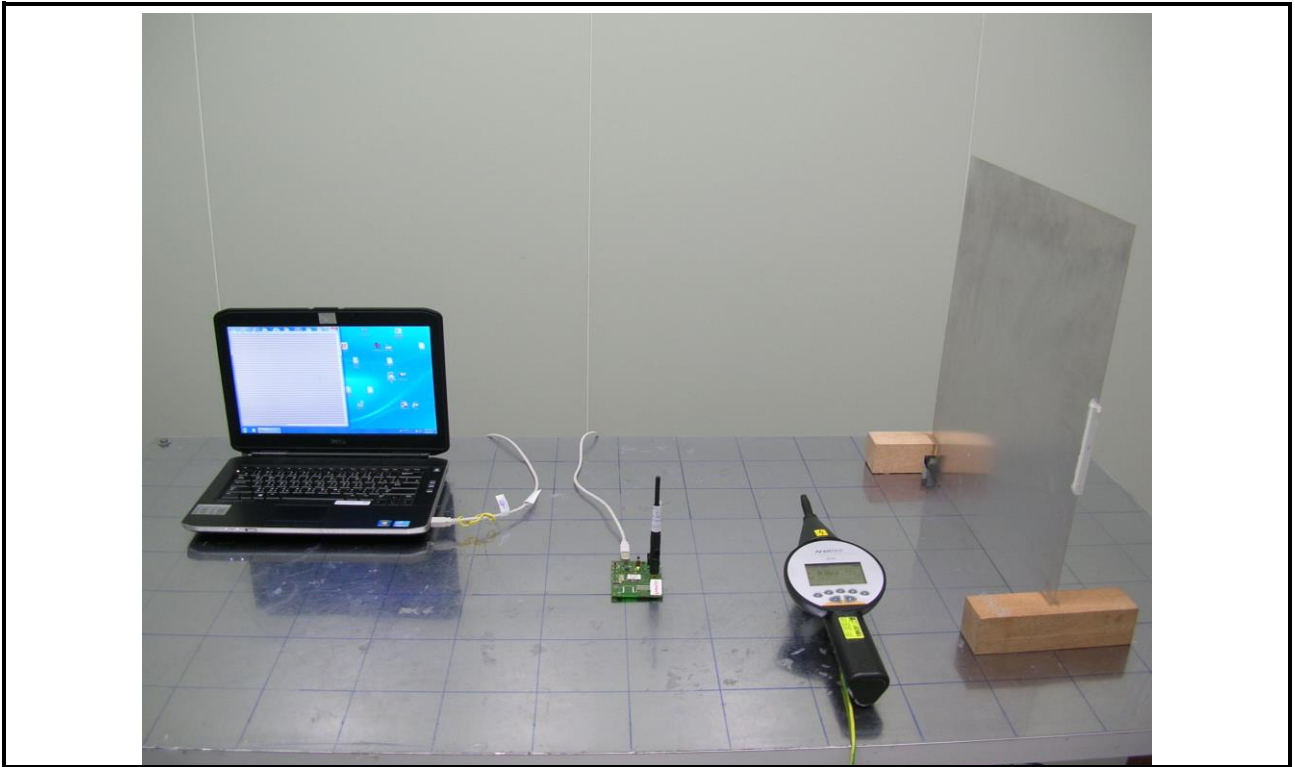
ESD Test (Mode 1)



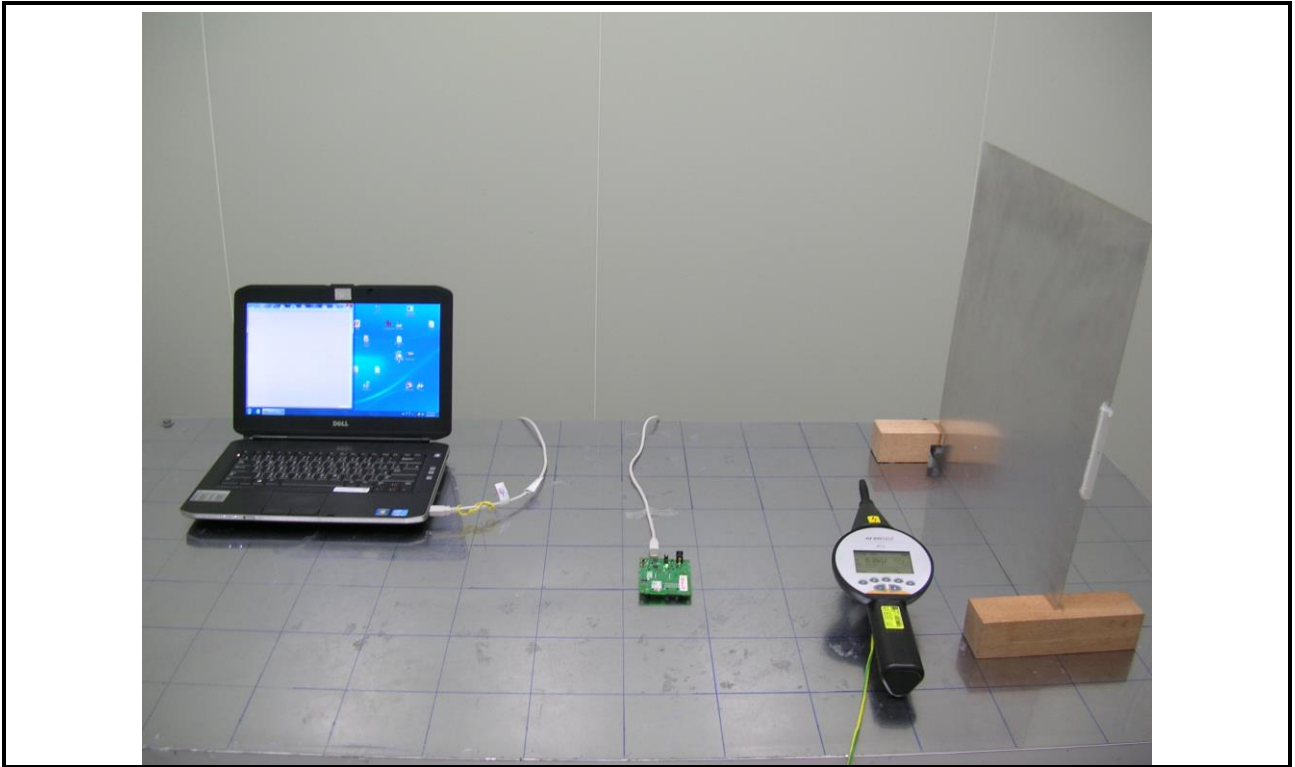
ESD Test (Mode 2)



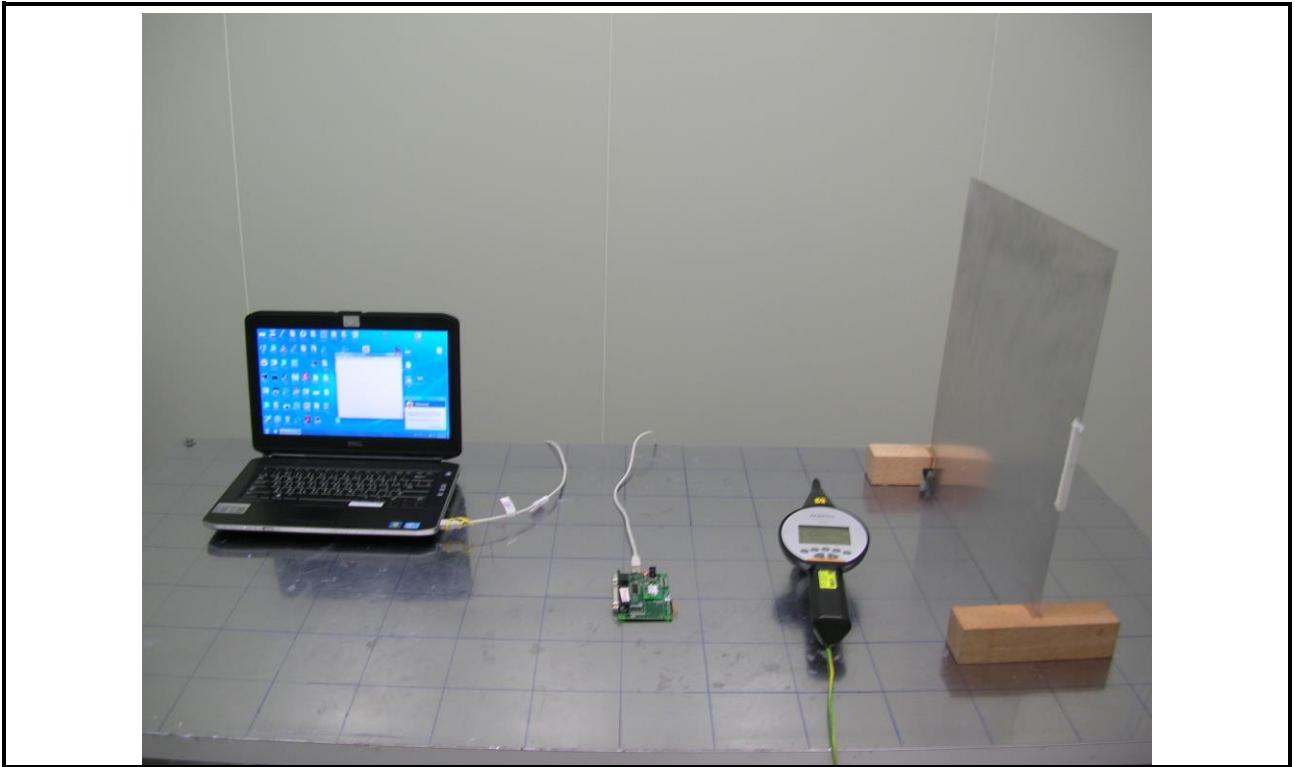
ESD Test (Mode 3)



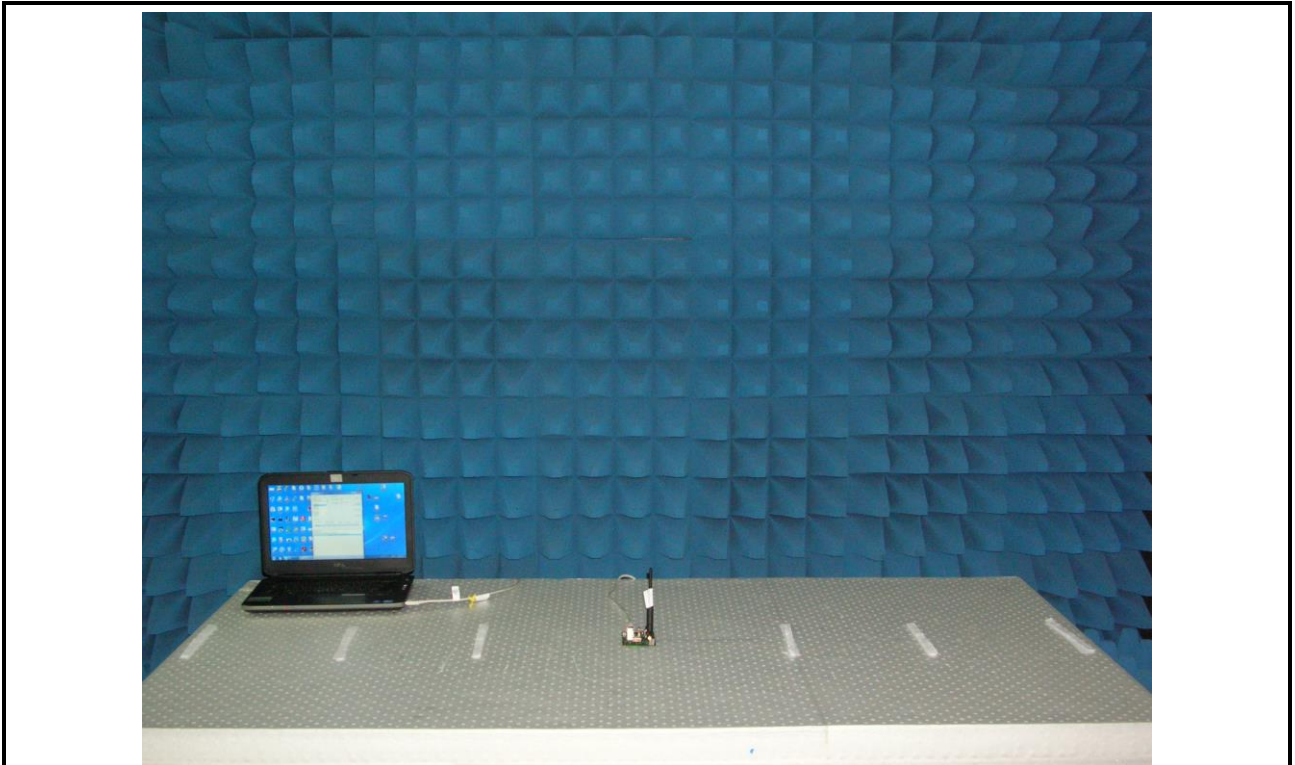
ESD Test (Mode 4)



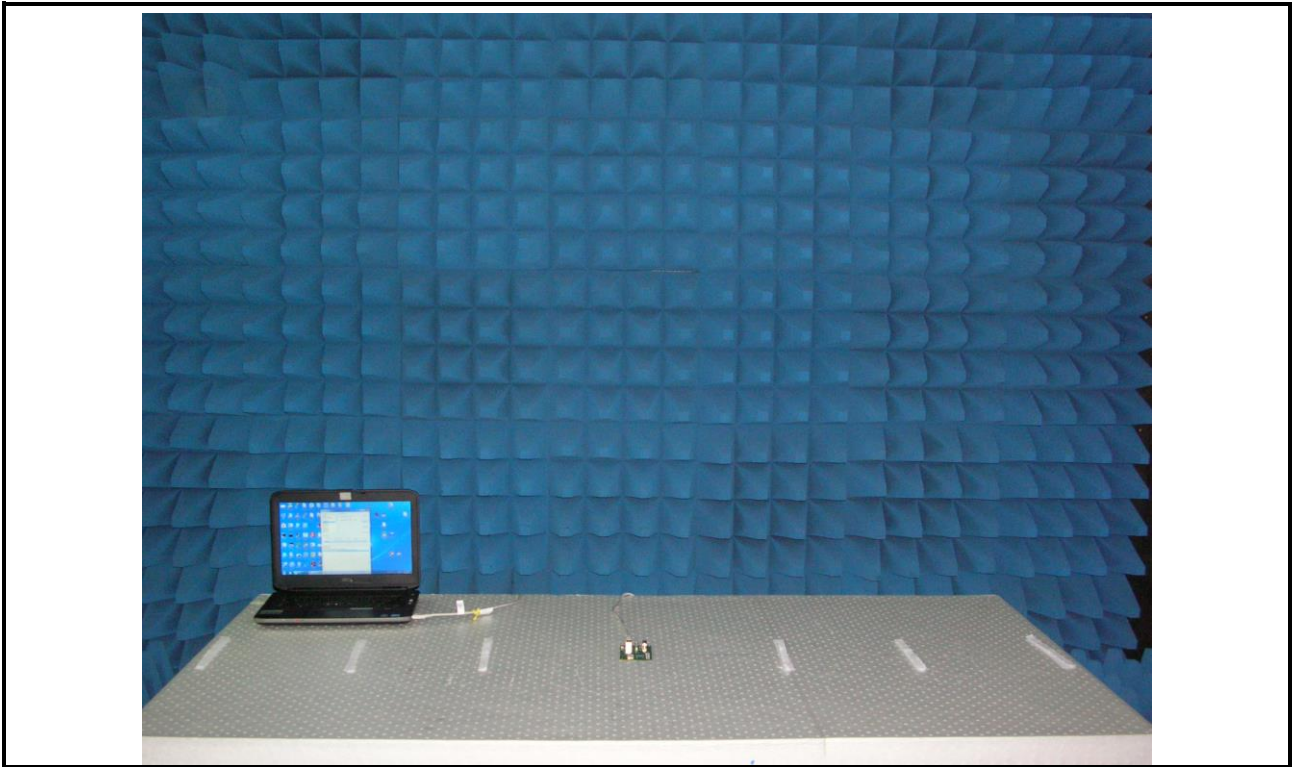
ESD Test (Mode 5)



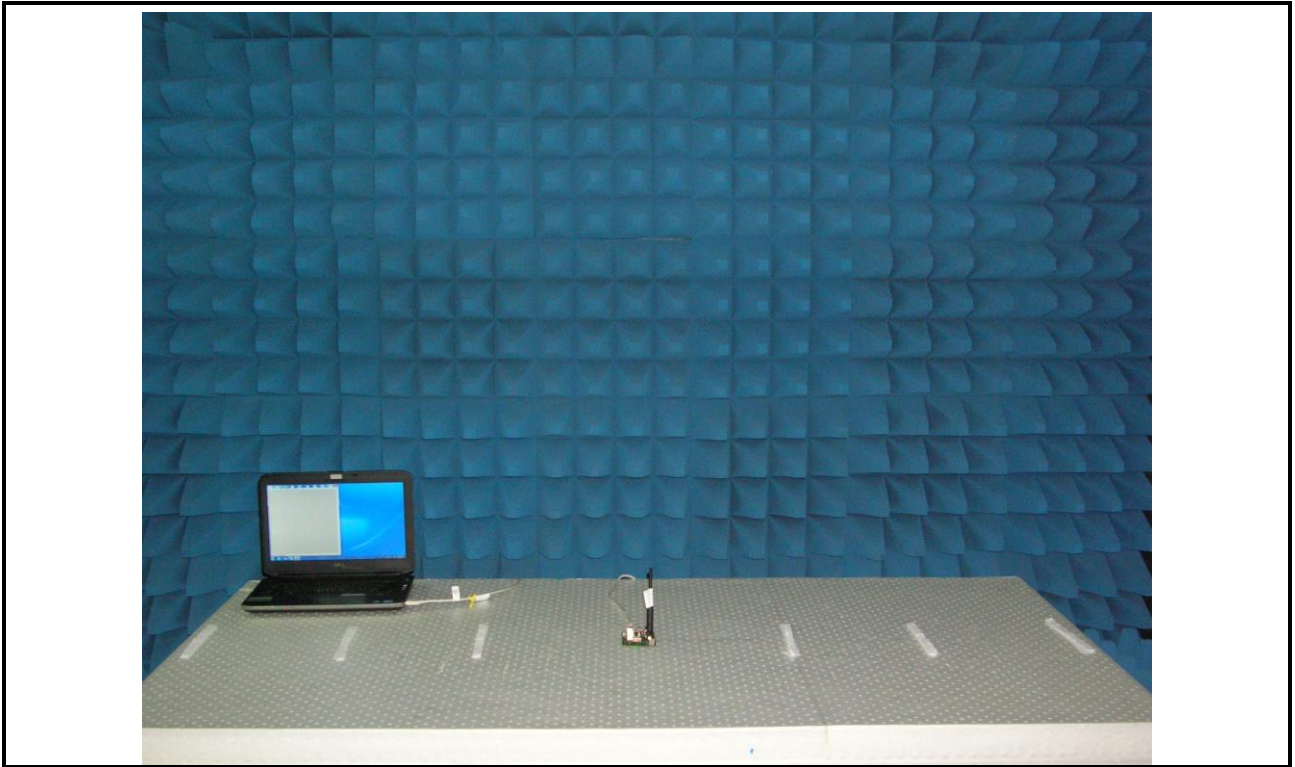
RS Test (Mode 1)



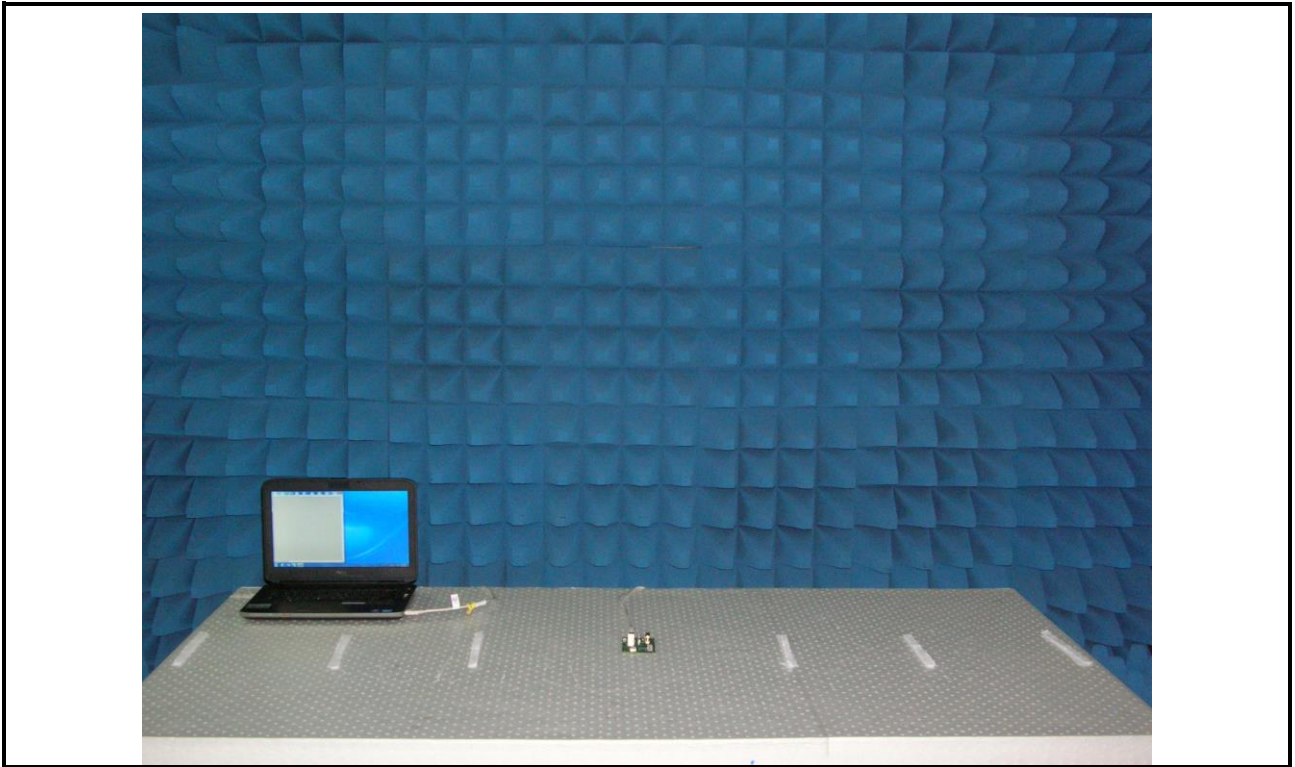
RS Test (Mode 2)



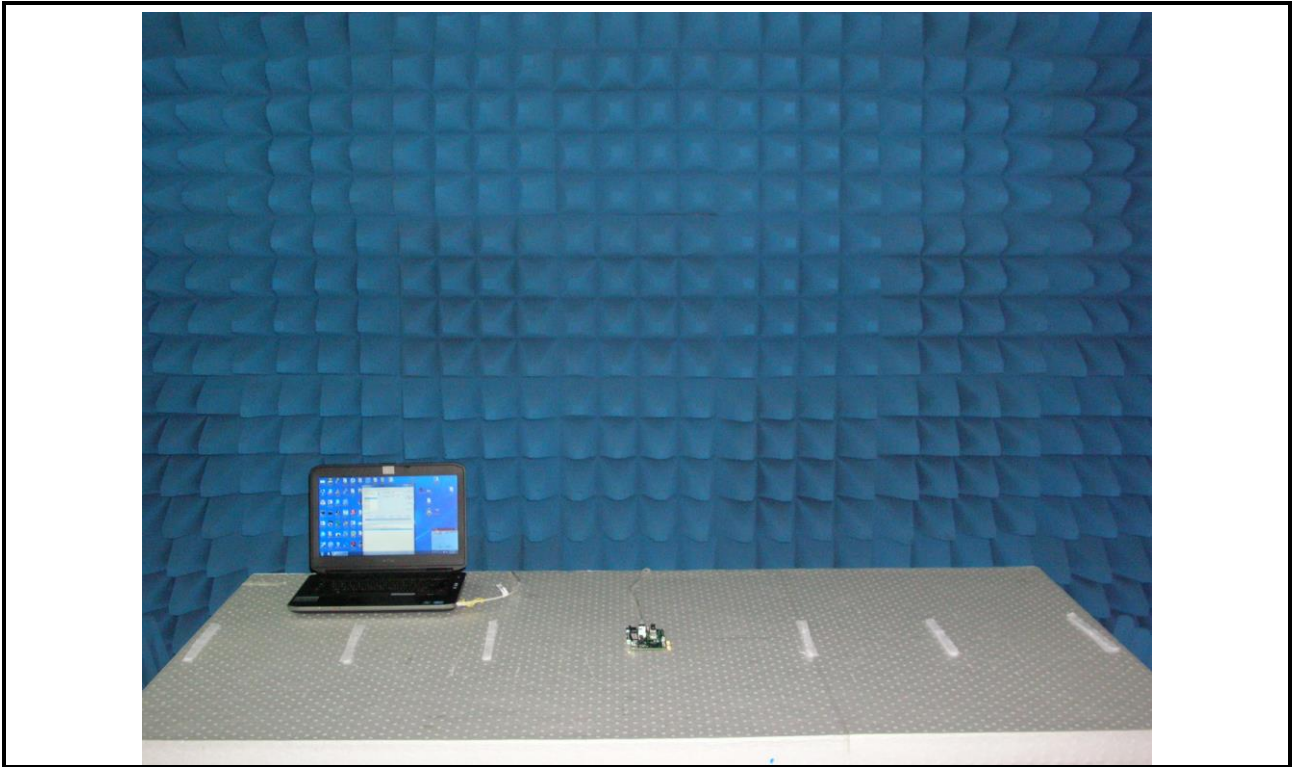
RS Test (Mode 3)



RS Test (Mode 4)



RS Test (Mode 5)



6 Test laboratory information

Established in 2012, ICC provides foremost EMC & RF Testing and advisory consultation services by our skilled engineers and technicians. Our services employ a wide variety of advanced edge test equipment and one of the widest certification extents in the business.

International Certification Corp, it is our definitive objective is to institute long term, trust-based associations with our clients. The expectation we set up with our clients is based on outstanding service, practical expertise and devotion to a certified value structure. Our passion is to grant our clients with best EMC / RF services by oriented knowledgeable and accommodating staff.

Our Test sites are located at Linkou District and Kwei Shan Hsiang. Location map can be found on our website <http://www.icertifi.com.tw>.

Linkou

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R.O.C.

Kwei Shan

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No. 3-1, Lane 6, Wen San 3rd
St., Kwei Shan Hsiang, Tao Yuan
Hsien 333, Taiwan, R.O.C.

Kwei Shan Site II

Tel: 886-3-271-8640

No. 14-1, Lane 19, Wen San 3rd
St., Kwei Shan Hsiang, Tao Yuan
Hsien 333, Taiwan, R.O.C.

If you have any suggestion, please feel free to contact us as below information

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Email: ICC_Service@icertifi.com.tw

==END==